

SKY53510/SKY53580/SKY53540 Low-Power DC to 3.1 GHz Ultra-Low Additive Jitter Differential Clock Buffers

The SKY53510/80/40 family of fanout buffers is ideal for high-frequency, low-jitter clock distribution. These devices feature universal level format translation and ultra-low additive RMS phase jitter over a wide range of conditions, including frequency and input clock slew rate.

Separate core and output voltages are included, supporting down to 1.8 V to enable additional power savings.

Built-in LDOs deliver high PSRR performance and reduce the need for external components, simplifying low-jitter clock distribution in noisy environments.

The SKY53510/80/40 features a selectable input clock using a 3:1 input mux, one single-ended output, and either 10, 8, or 4 differential outputs in two banks, each of which is selectable as LVPECL, LVDS, HCSL, or tristate and whose voltage supply is independently sourced with either 1.8 V, 2.5 V, or 3.3 V.

Each output bank has its own dedicated 1.8 V, 2.5 V, or 3.3 V output voltage supply. This buffer family can be paired with the Skyworks NetSync™ family of network synchronizer clocks, jitter attenuators, and clock generators and oscillators to deliver ultra-low-jitter clock tree solutions.

- Two banks of differential output clocks
 - 10/8/4 output ordering options
 - Pin-selectable output formats (per bank): LVPECL, LVDS, HCSL
- Frequency range:
 - LVPECL: dc to 3.1 GHz
 - LVDS: dc to 3 GHz
 - HCSL: dc to 800 MHz
- PCIe Gen1/2/3/4/5/6/7 compliant
- Low-power operation (VDD/VDDO)
 - 1.8 V/2.5 V/3.3 V
- LVCMOS output with synchronous enable/disable
- Temperature range:
 - -40 to +95 °C ambient temperature
 - 105 °C max board temperature
- Packages:
 - SKY53510: 48-pin, 7 x 7 mm QFN
 - SKY53580: 40-pin, 6 x 6 mm QFN
 - SKY53540: 32-pin, 5 x 5 mm QFN
- For RoHS and other product compliance information, see the [Skyworks Certificate of Conformance](#).

Key Features

- Ultra-low additive jitter (156.25 MHz LVPECL, 12 kHz to 20 MHz):
 - 35 fs RMS typical
 - 47 fs RMS max
- 3:1 Input multiplexer
 - Two any-format universal inputs supporting LVPECL, LVDS, S-LVDS, HCSL, CML, SSTL, and HSTL
 - One crystal input (also accepts a single-ended clock)

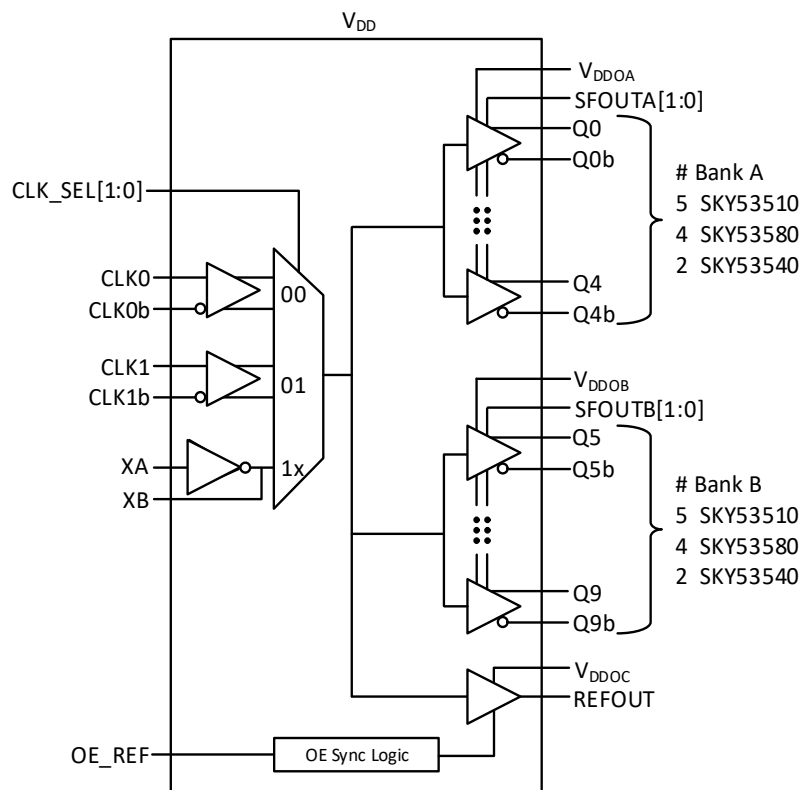
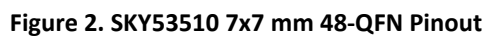


Figure 1. Functional Block Diagram

1.1. SKY53510 7x7 mm 48-QFN Pin Descriptions



Pin	Name	Type ¹	Description
1	Q0	O	Output Clock 0
2	Q0b	O	Output Clock 0 (complement)
3	Q1	O	Output Clock 1
4	Q1b	O	Output Clock 1 (complement)
5	VDDOA	P	Output voltage supply—Bank A (Outputs: Q0 to Q4) Bypass with 0.1 μF capacitor and place as close to the VDDOA pin as possible.
6	Q2	O	Output Clock 2
7	Q2b	O	Output Clock 2 (complement)
8	VDDOA	P	Output voltage supply—Bank A (Outputs: Q0 to Q4) Bypass with 0.1 μF capacitor and place as close to the VDDOA pin as possible.
9	Q3	O	Output Clock 3
10	Q3b	O	Output Clock 3 (complement)
11	Q4	O	Output Clock 4
12	Q4b	O	Output Clock 4 (complement)
13	GND	GND	Ground

Table 1. SKY53510 7x7mm 48-QFN Pin Descriptions (Continued)

Pin	Name	Type ¹	Description
14	SFOUTA0	I	Output signal format control pin for Bank A. SFOUTA0 contains an internal pull-down resistor.
15	VDD	P	Core voltage supply. Bypass with 0.1 μ F capacitor placed as close to the VDD pin as possible.
16	XA	I	Crystal input. Can also be driven by a XO, TCXO, or other external single-ended clock.
17	XB	O	Crystal output. When a crystal is not used, and XA is used as an input, this pin should be left floating.
18	GND	GND	Ground
19	CLK_SEL0	I	Mux input select pin. CLK_SEL0 contains an internal pull-down resistor.
20	CLK0	I	Input Clock 0
21	CLK0b	I	Input Clock 0 (complement).
22	CLK_SEL1	I	Mux input select pin. CLK_SEL1 contains an internal pull-down resistor.
23	SFOUTB0	I	Output signal format control pin for Bank B. SFOUTB0 contains an internal pull-down resistor.
24	GND	GND	Ground
25	Q9b	O	Output Clock 9 (complement)
26	Q9	O	Output Clock 9
27	Q8b	O	Output Clock 8 (complement)
28	Q8	O	Output Clock 8
29	VDDOB	P	Output voltage supply—Bank B (Outputs: Q5 to Q9). Bypass with 0.1 μ F capacitor and place as close to the VDDOB pin as possible.
30	Q7b	O	Output Clock 7 (complement)
31	Q7	O	Output Clock 7
32	VDDOB	P	Output voltage supply—Bank B (Outputs: Q5 to Q9). Bypass with 0.1 μ F capacitor and place as close to the VDDOB pin as possible.
33	Q6b	O	Output Clock 6 (complement).
34	Q6	O	Output Clock 6.
35	Q5b	O	Output Clock 5 (complement)
36	Q5	O	Output Clock 5
37	GND	GND	Ground
38	NC	-	No connect. Leave this pin floating.
39	SFOUTB1	I	Output signal format control pin for Bank B. SFOUTB1 contains an internal pull-down resistor.
40	CLK1b	I	Input Clock 1 (complement).
41	CLK1	I	Input Clock 1.
42	VDD	P	Core voltage supply. Bypass with 0.1 μ F capacitor placed as close to the VDD pin as possible.
43	GND	GND	Ground.
44	REFOUT	O	LVCMOS reference output clock. Enable this output by pulling pin 46 high.

Table 1. SKY53510 7x7mm 48-QFN Pin Descriptions (Continued)

Pin	Name	Type ¹	Description
45	VDDOC	P	REFOUT buffer supply. Bypass with 0.1 μ F capacitor placed as close to the VDDOC pin as possible.
46	OE_REF	I	Output Enable for REFOUT. OE_REF contains an internal pull-down resistor.
47	SFOUTA1	I	Output signal format control pin for Bank A. SFOUTA1 contains an internal pull-down resistor.
48	GND	GND	Ground.
GND Pad	GND	GND	Power supply ground and thermal relief.

1. Pin types are: I = input, O = output, P = power, GND = ground.

1.2. SKY53580 6x6 mm 40-QFN Pin Descriptions

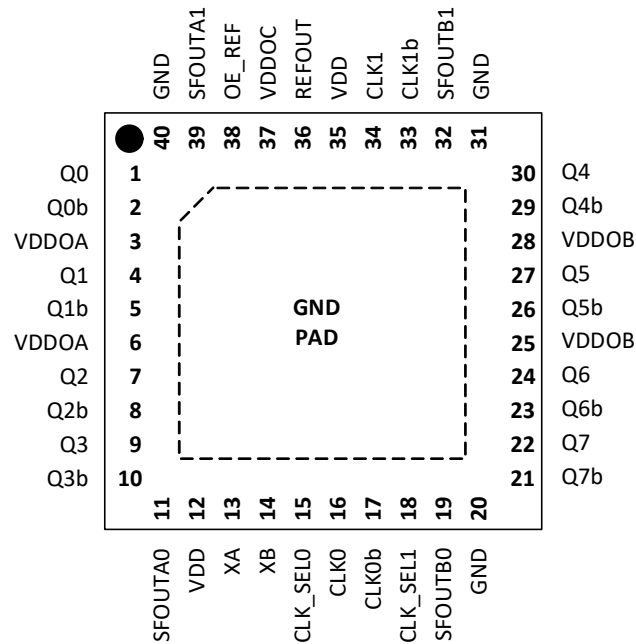


Figure 3. SKY53580 6x6 mm 40-QFN Pinout

Table 2. SKY53580 6x6 mm 40-QFN Pin Descriptions

Pin	Name	Type ¹	Description
1	Q0	O	Output Clock 0.
2	Q0b	O	Output Clock 0 (complement).
3	VDDOA	P	Output voltage supply-Bank A (Outputs: Q0 to Q3). Bypass with 0.1 μ F capacitor and place as close to the VDDOA pin as possible.
4	Q1	O	Output Clock 1.
5	Q1b	O	Output Clock 1 (complement).
6	VDDOA	P	Output voltage supply-Bank A (Outputs: Q0 to Q3). Bypass with 0.1 μ F capacitor and place as close to the VDDOA pin as possible.
7	Q2	O	Output Clock 2.
8	Q2b	O	Output Clock 2 (complement).
9	Q3	O	Output Clock 3.
10	Q3b	O	Output Clock 3 (complement).
11	SFOUTA0	I	Output signal format control pin for Bank A. SFOUTA0 contains an internal pull-down resistor.
12	VDD	P	Core voltage supply. Bypass with 0.1 μ F capacitor placed as close to the VDD pin as possible.
13	XA	I	Crystal input. Can also be driven by a XO, TCXO, or other external single-ended clock.
14	XB	O	Crystal output. When a crystal is not used, and XA is used as an input, this pin should be left floating.
15	CLK_SELO	I	Mux input select pin. CLK_SELO contains an internal pull-down resistor.

Table 2. SKY53580 6x6 mm 40-QFN Pin Descriptions (Continued)

Pin	Name	Type ¹	Description
16	CLK0	I	Input Clock 0.
17	CLK0b	I	Input Clock 0 (complement).
18	CLK_SEL1	I	Mux input select pin. CLK_SEL1 contains an internal pull-down resistor.
19	SFOUTB0	I	Output signal format control pin for Bank B. SFOUTB0 contains an internal pull-down resistor.
20	GND	GND	Ground.
21	Q7b	O	Output Clock 7 (complement).
22	Q7	O	Output Clock 7.
23	Q6b	O	Output Clock 6 (complement).
24	Q6	O	Output Clock 6.
25	VDDOB	P	Output voltage supply-Bank B (Outputs: Q4 to Q7). Bypass with 0.1 μ F capacitor and place as close to the VDDOB pin as possible.
26	Q5b	O	Output Clock 5 (complement).
27	Q5	O	Output Clock 5.
28	VDDOB	P	Output voltage supply-Bank B (Outputs: Q4 to Q7). Bypass with 0.1 μ F capacitor and place as close to the VDDOB pin as possible.
29	Q4b	O	Output Clock 4 (complement).
30	Q4	O	Output Clock 4.
31	GND	GND	Ground.
32	SFOUTB1	I	Output signal format control pin for Bank B. SFOUTB1 contains an internal pull-down resistor.
33	CLK1b	I	Input Clock 1 (complement).
34	CLK1	I	Input Clock 1.
35	VDD	P	Core voltage supply. Bypass with 0.1 μ F capacitor placed as close to the VDD pin as possible.
36	REFOUT	O	LVCMOS reference output clock. Enable this output by pulling pin 38 high.
37	VDDOC	P	REFOUT buffer supply. Bypass with 0.1 μ F capacitor placed as close to the VDDOC pin as possible.
38	OE_REF	I	Output Enable for REFOUT. OE_REF contains an internal pull-down resistor.
39	SFOUTA1	I	Output signal format control pin for Bank A. SFOUTA1 contains an internal pull-down resistor.
40	GND	GND	Ground.
GND Pad	GND	GND	Power supply ground and thermal relief.

1. Pin types are: I = input, O = output, P = power, GND = ground.

1.3. SKY53540 5x5 mm 32-QFN Pin Descriptions

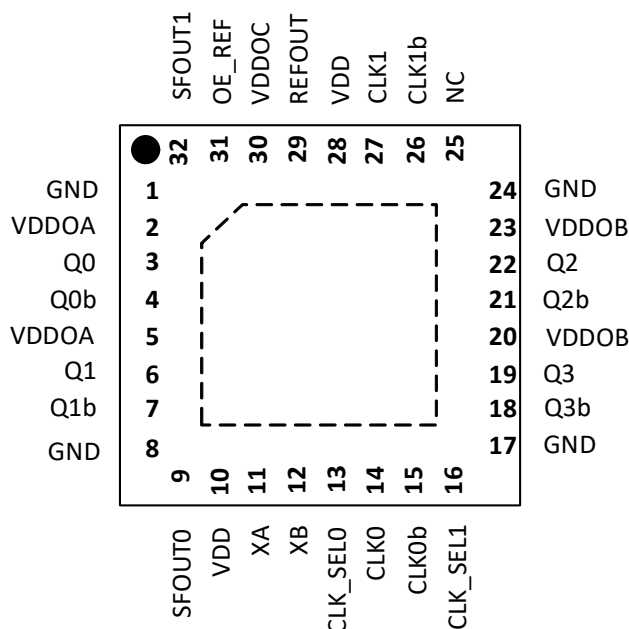


Figure 4. SKY53540 5x5 mm 32-QFN Pinout

Table 3. SKY53540 5x5 mm 32-QFN Pin Descriptions

Pin	Name	Type ¹	Description
1	GND	GND	Ground.
2	VDDOA	P	Output voltage supply-Bank A (Outputs: Q0 to Q1). Bypass with 0.1 μ F capacitor and place as close to the VDDOA pin as possible.
3	Q0	O	Output clock 0.
4	Q0b	O	Output clock 0 (complement).
5	VDDOA	P	Output voltage supply-Bank A (Outputs: Q0 to Q1). Bypass with 1.0 μ F capacitor and place as close to the VDDOA pin as possible.
6	Q1	O	Output clock 1.
7	Q1b	O	Output clock 1 (complement).
8	GND	GND	Ground.
9	SFOUT0	I	Output signal format control pin for Bank A and Bank B. SFOUT0 contains an internal pull-down resistor.
10	VDD	P	Core voltage supply. Bypass with 0.1 μ F capacitor placed as close to the VDD pin as possible.
11	XA	I	Crystal input. Can also be driven by a XO, TCXO, or other external single-ended clock.
12	XB	O	Crystal output. When a crystal is not used and XA is used as an input, this pin should be left floating.
13	CLK_SELO	I	Mux input select pin. CLK_SELO contains an internal pull-down resistor.
14	CLK0	I	Input clock 0.

Table 3. SKY53540 5x5 mm 32-QFN Pin Descriptions (Continued)

Pin	Name	Type ¹	Description
15	CLK0b	I	Input clock 0 (complement).
16	CLK_SEL1	I	Mux input select pin. CLK_SEL1 contains an internal pull-down resistor.
17	GND	GND	Ground.
18	Q3b	O	Output clock 3 (complement).
19	Q3	O	Output clock 3.
20	VDDOB	P	Output voltage supply-Bank B (Outputs: Q2 to Q3). Bypass with 0.1 μ F capacitor and place as close to the VDDOB pin as possible.
21	Q2b	O	Output clock 2 (complement).
22	Q2	O	Output clock 2.
23	VDDOB	P	Output voltage supply-Bank B (Outputs: Q2 to Q3). Bypass with 0.1 μ F capacitor and place as close to the VDDOB pin as possible.
24	GND	GND	Ground.
25	NC	—	No Connect.
26	CLK1b	I	Input clock 1 (complement).
27	CLK1	I	Input clock 1.
28	VDD	P	Core voltage supply. Bypass with 0.1 μ F capacitor placed as close to the VDD pin as possible.
29	REFOUT	O	LVC MOS reference output clock. Enable this output by pulling Pin 31 high.
30	VDDOC	P	REFOUT buffer supply. Bypass with 0.1 μ F capacitor placed as close to the VDDOC pin as possible.
31	OE_REF	I	Output Enable for REFOUT. OE_REF contains an internal pull-down resistor.
32	SFOUT1	I	Output signal format control pin for Bank A and Bank B. SFOUT1 contains an internal pull-down resistor.
GNDPad	GND	GND	Power supply ground and thermal relief.

1. Pin types are: I = input, O = output, P = power, GND = ground.

2. Detailed Description

2.1. Overview

The SKY53510/80/40 is a family of ultra-low additive jitter, low-skew, universal/any-format buffers. These devices can operate up to 3.1 GHz, featuring a 3:1 input multiplexer stage that can accept the most common differential or LVCMOS input signals. The output stage includes two banks of outputs, each of which includes pin-selectable output format selection and output supply voltage, as well as an LVCMOS reference output.

2.2. Block Diagrams

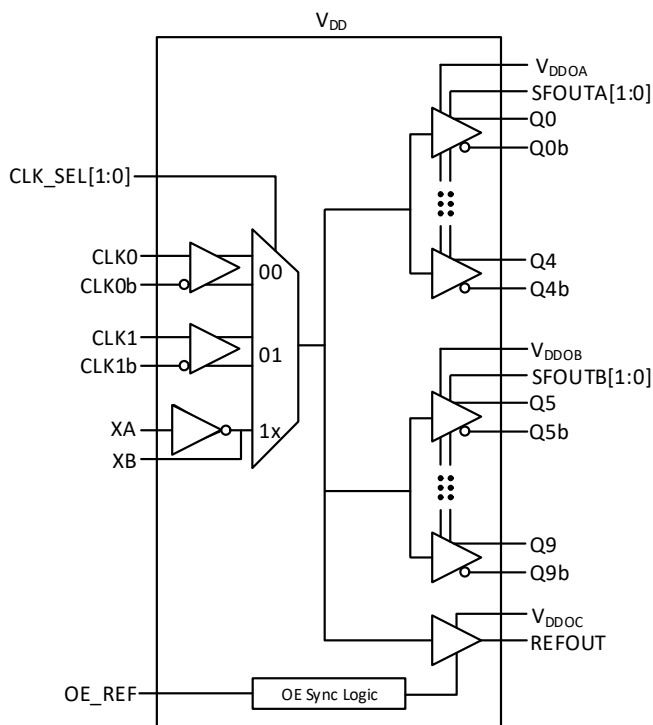


Figure 5. SKY53510 Block Diagram

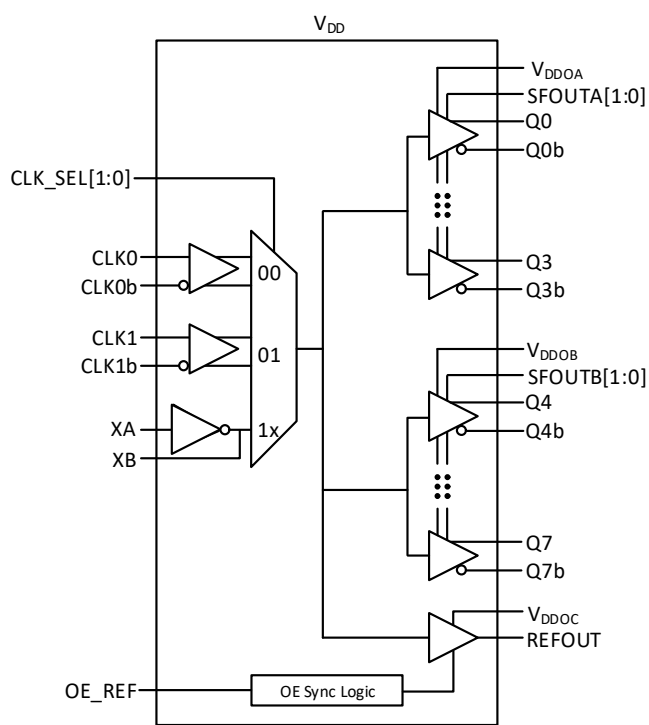


Figure 6. SKY53580 Block Diagram

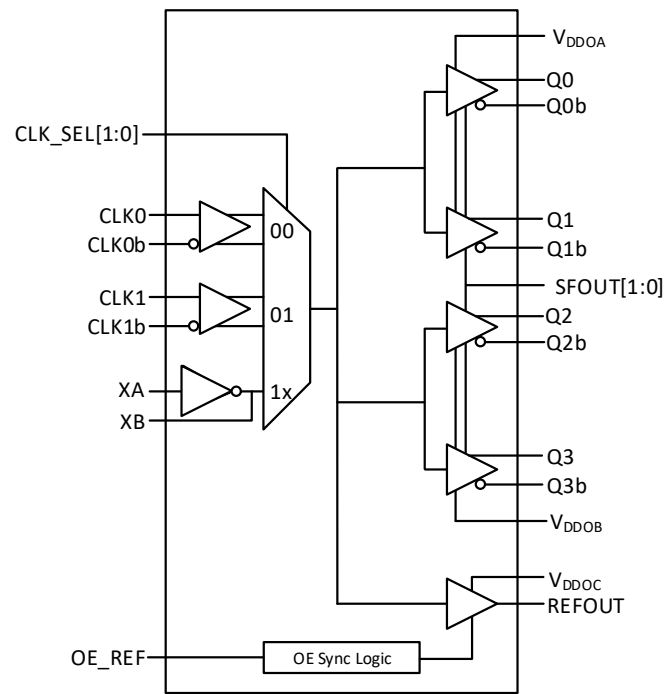


Figure 7. SKY53540 Block Diagram

2.3. Modes of Operation

2.3.1. Input Clock Stage

The input stage accepts a wide variety of common clock formats and voltage ranges on CLK0 and CLK1, including LVPECL, LVCMOS, LVDS, HCSL, CML, SSTL, and HSTL. For ac-coupled, sine-wave clock inputs, see “AN1405: SKY535xx Applications Guide”. For the best high-speed performance, differential formats are recommended. The SKY53510/80/40 exhibits excellent additive RMS phase jitter across a wide spectrum of input slew rates for both single-ended and differential input clocks.

To achieve optimal performance, a differential slew rate of 3.0 V/ns is recommended for differential formats, and 1.0 V/ns for single-ended formats to meet the max RMS additive phase jitter data sheet specifications. The buffers remain fully functional with slower slew rates but will incur some degradation in jitter performance. See Figure 53 on page 39 for further information on additive RMS phase jitter performance vs. input clock slew rate. For input frequencies below 1 MHz, dc-coupled interfaces are recommended. For more information, see “AN766: Understanding and Optimizing Clock Buffer's Additive Jitter Performance”.

Table 4. DC-Coupled Clock Input Options on CLK0/CLK1

Clock Format	VDD = 1.8 V	VDD = 2.5/3.3 V
LVPECL	No	Yes
LVCMOS	Yes	Yes
LVDS / S-LVDS	Yes	Yes
HCSL	Yes	Yes

The input clock can be selected from CLK0/CLK0b, CLK1/CLK1b, or the crystal input (XA/XB). The CLK_SEL[1:0] pins select the active clock input and have internal pull-down resistors. The following tables summarize the input and output clock configurations based on the input multiplexer CLK_SEL[1:0] pin settings. A single rising edge on the selected input clock is required for the output to then reflect the input source. Clock inputs should not be driven until VDD has reached the recommended minimum level.

Table 5. Input Selection^{1,2,3}

CLK_SEL1	CLK_SELO	Selected Input
0	0	CLK0/CLK0b
0	1	CLK1/CLK1b
1	X	Crystal input (XA/XB)

1. CLK_SEL[1:0] have internal pull-down resistors. When left open, the pin is internally pulled to ground. To pull high, use a 4.7 kΩ resistor to VDD.

2. When XA is used as an AC coupled single-ended input in place of the crystal, XB should be left electrically unconnected.

3. Unused CLK0/1 inputs may be left floating. Unused XA should be tied to ground to prevent system noise from affecting this input.

Table 6. Clock Input vs. Output States^{1,2}

State of Selected Clock Input	State of Enabled Clock Outputs ²
CLK0/CLK0b and CLK1/CLK1b inputs shorted together via 100 Ω resistor	Logic low
CLK0/CLK0b or CLK1/CLK1b input logic low.	Logic low
CLK0/CLK0b or CLK1/CLK1b input logic high.	Logic high

1. Upon power up, a single rising edge at the selected input is required for the outputs to reflect the input source.

2. If the selected clock input is not driven, a 100 Ω resistor should be placed between CLKx/CLKxb for the state of enabled outputs to be logic low. Omission of the 100 Ω resistor may result in undesired chatter on enabled outputs.

2.3.2. Clock Outputs

The highly flexible output drivers support a wide range of clock signal formats, including LVPECL, LVDS, and HCSL. The differential output format type for Bank A and Bank B outputs are independently configurable using the SFOUTA[1:0] and SFOUTB[1:0] input pins, respectively, as shown in Table 7 below. This feature enables the device to be used for format/level translation in addition to clock distribution, minimizing the number of unique buffer part numbers required in a typical application and simplifying design reuse. For applications where all differential outputs are not required, any unused Qn/Qnb output pin should be left floating with a minimal copper length to minimize capacitance, potential coupling, and power consumption. It is recommended to disable (Hi-Z) the bank to reduce power if no outputs will be used from that respective bank. See the termination diagrams in “3.3. Clock Output Termination” on page 18.

Table 7. Output Signal Format Selection

SFOUTx[1] ¹	SFOUTx[0] ¹	V _{DDOx} = 3.3 V	V _{DDOx} = 2.5 V	V _{DDOx} = 1.8 V
0	0	LVPECL	LVPECL	N/A ²
0	1	LVDS	LVDS	S-LVDS
1	0	HCSL	HCSL	HCSL
1	1	Disabled (Hi-Z) ³	Disabled (Hi-Z) ³	Disabled (Hi-Z) ³

1. SFOUTx[1:0] have internal pulldown resistors. When left open, the pin is internally pulled to ground. To pull high, use a 4.7 kΩ resistor to VDD.
2. The hardware default output format for 1.8 V is undefined. One or both of the SFOUTx pins should either be driven by the system or pulled up to VDD using a 4.7 kΩ resistor.
3. To power up the buffer with inactive outputs, pull both SFOUTx pins to VDD with 4.7 kΩ resistors.

The device also features an LVCMOS clock output (REFOUT) at the same frequency as the selected clock input, which can be enabled/disabled via the OE_REF pin. The OE_REF pin is sampled and synchronized to the falling edge of the selected input clock. This feature prevents runt pulses from being generated when REFOUT is enabled. REFOUT will be synchronously enabled within three cycles of the input clock after OE_REF is driven high and meets setup and hold timing requirements.

When OE_REF is low, REFOUT is disabled synchronously in a Hi-Z state. This allows the disabled state to be determined by external bias. For example, if a 1 kΩ resistor is connected from REFOUT to ground, REFOUT will be pulled low when disabled.

Table 8. Reference Output Enable¹

OE_REF	REFOUT
0	Disabled (Hi-Z)
1	Enabled

1. All unused outputs from Bank A, Bank B, or REFOUT should be left unconnected and floating.

3. Applications Information

3.1. Driving Clock Inputs (CLK0/CLK1)

The SKY53510/80/40 features two universal, any-format clock inputs that can accept ac-coupled LVPECL, LVDS, HCSL, CML, SSTL, HSTL, and ac-coupled, single-ended clocks, or dc-coupled LVPECL, LVDS, HCSL, or LVCMOS clock inputs. Inputs must not be driven prior to VDD reaching the recommended minimum level. The devices feature excellent additive RMS phase jitter over a wide range of clock input slew rates as shown in [Figure 53 on page 39](#). To achieve the best additive RMS phase jitter performance on the output clocks, Skyworks recommends a differential input with a high differential slew rate of 3 V/ns or higher.

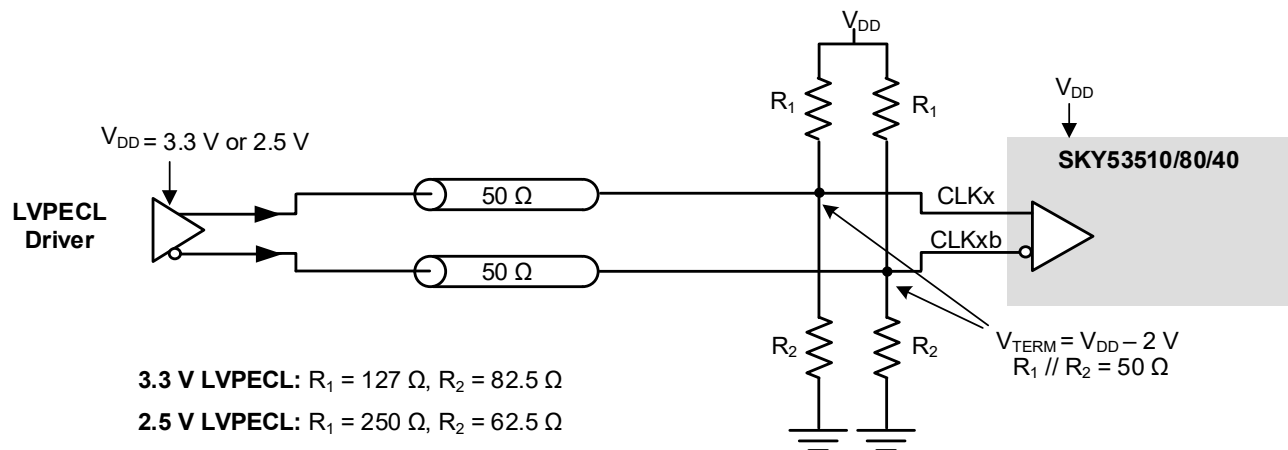


Figure 8. DC-Coupled LVPECL Input Termination Scheme 1

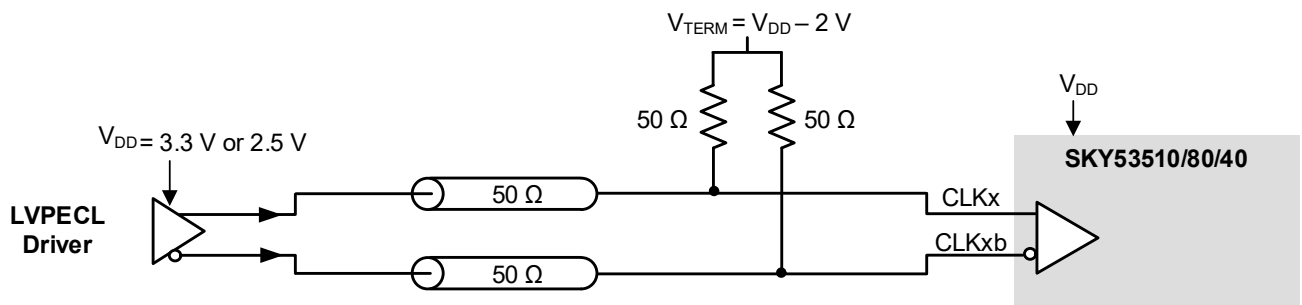


Figure 9. DC-Coupled LVPECL Input Termination Scheme 2

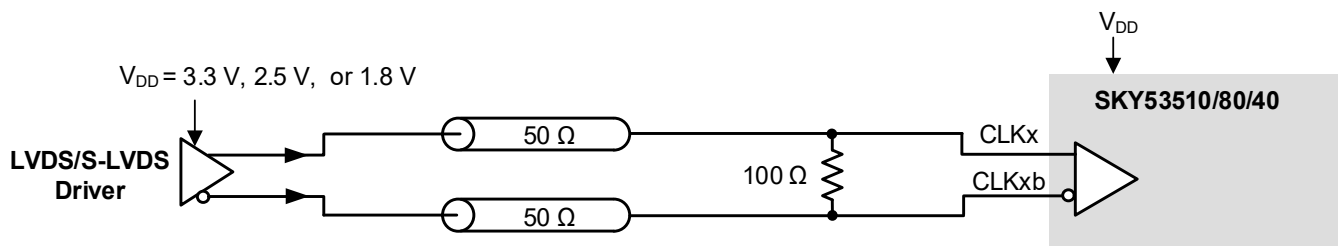
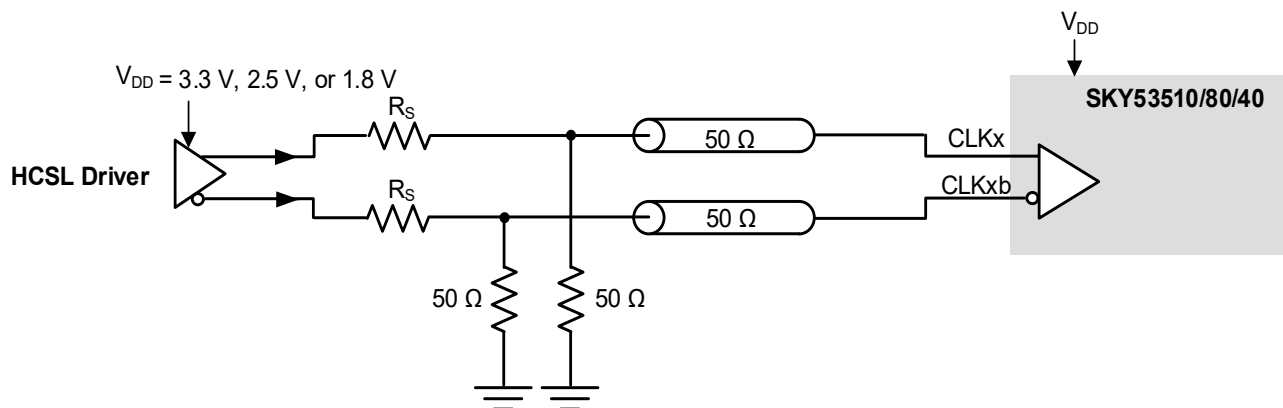


Figure 10. DC Coupled LVDS/S-LVDS Input Termination



Note: R_s series termination is optional depending on the location of the receiver.
Adding R_s will reduce the amplitude of the output driver swing seen at the receiver.

Figure 11. DC-Coupled HCSL Input Termination

The device features internal common mode biasing to support ac-coupled differential input clocks. While it is not recommended, driving the CLK0 or CLK1 input pins with a single-ended clock is possible, as long as the clock conforms to the single-ended input specifications outlined in [Table 11, “Input Clock Specifications,” on page 25](#). Single-ended input clocks can be ac-coupled, using the configurations shown in [Figure 12](#) or [Figure 13](#). The output impedance of the LVCMOS driver plus R_s should be close to 50 Ω to match the characteristic impedance of the transmission line and load termination.

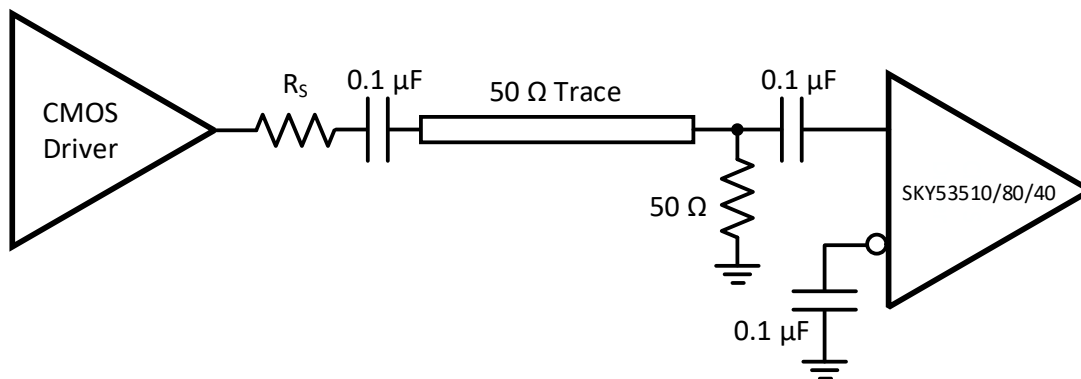


Figure 12. Single-Ended Input Termination Scheme 1 (AC Coupling)

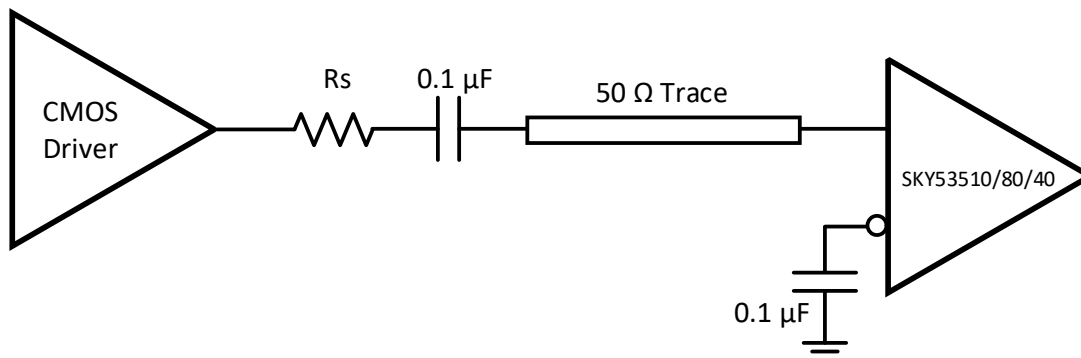


Figure 13. Single-Ended Input Termination Scheme 2 (AC Coupling)

A single-ended clock may also be dc coupled to CLK0 or CLK1 as shown in Figure 14. Place a 50 Ω load resistor near the CLK0 or CLK1 input pin for signal attenuation and line termination. Half of the single-ended swing of the driver (voltage seen at the 50 Ω load will depend on the R_S and CMOS source impedance) drives CLK0 or CLK1, therefore CLK0b or CLK1b should be externally biased to the midpoint voltage of the attenuated input swing ($(V_{O,PP} / 2) \times 0.5$). The external bias voltage should be within the specified input common-mode voltage (V_{CM}) range specified in “5. Electrical Specifications” on page 24. This can be achieved using external biasing resistors in the k Ω range (R_{B1} and R_{B2}) or another low-noise voltage reference. Doing so will ensure the input swing crosses the threshold voltage at a point where the input slew rate is the highest. If the LVCMOS driver cannot achieve sufficient swing with a dc-terminated, 50 Ω load at the CLK0 or CLK1 input as shown in Figure 14, then consider connecting the 50 Ω load termination to ground through a capacitor (CAC). This ac termination blocks the dc load current on the driver, so the voltage swing at the input is determined by the voltage divider formed by the source ($R_o + R_S$) and 50 Ω load resistors. The value for CAC depends on the trace delay, T_d , of the 50 Ω transmission line; $CAC \geq 3 \times T_d / 50 \Omega$.

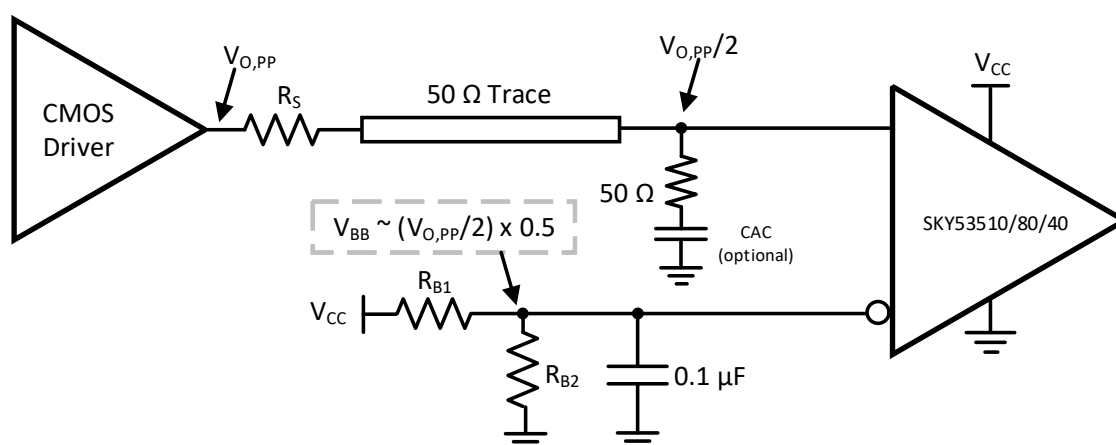


Figure 14. Single-Ended Input with Common-Mode Biasing Option1, DC Coupling

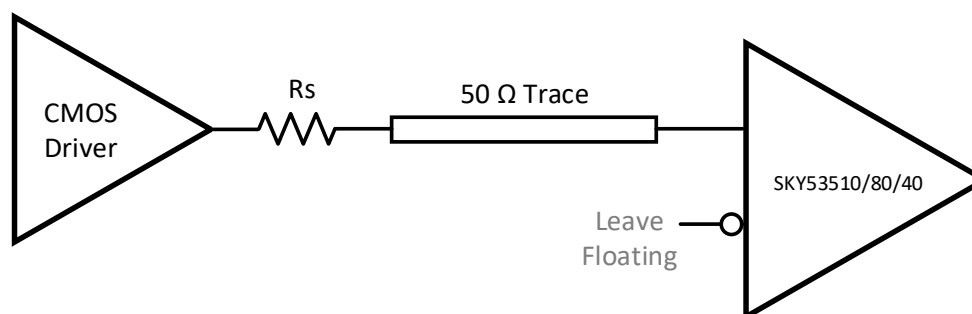


Figure 15. Single-Ended Input Option 2, DC Coupling

The input clock receivers on the SKY53510/80/40 do not have hysteresis; an internal biasing network prevents the receiver from switching due to board noise.

3.2. Crystal Interface (XA/XB)

The SKY53510/80/40 features an integrated crystal oscillator circuit in the input stage that supports a fundamental mode, AT-cut crystal input.

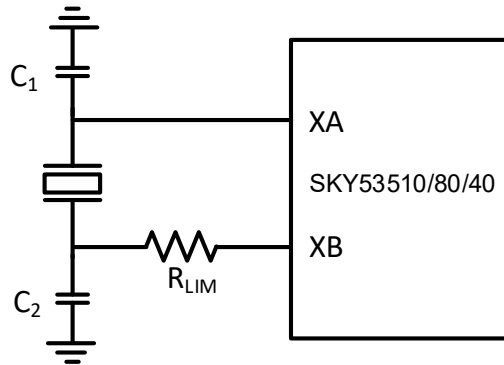


Figure 16. Crystal Interface

The external load capacitors (C1 and C2 in the figure above) are a function of capacitive parameters associated with the crystal, the input capacitance of the crystal oscillator circuit, and stray capacitance comprised of the parasitic capacitance of the board trace and bond pad capacitances. Details of how these capacitor values (C1 and C2) are calculated are provided in Application Note “AN1405: SKY535xx Applications Guide”.

Table 11, “Input Clock Specifications,” on page 25 provides crystal interface specifications with conditions that ensure start-up of the crystal, but it does not specify crystal power dissipation. The designer will need to ensure the crystal power dissipation does not exceed the maximum drive level specified by the crystal manufacturer. Overdriving the crystal can cause premature aging, frequency shift, and eventual failure. Drive level should be held at a sufficient level necessary to start-up and maintain steady-state operation.

The power dissipated in the crystal, P_{xtal} , can be computed by:

$$P_{xtal} = I_{RMS} \times R_{esr} \times (1 + C_o/C_l)^2$$

where:

- I_{RMS} is the RMS current through the crystal.
- R_{esr} is the maximum equivalent series resistance specified for the crystal
- C_l is the load capacitance specified for the crystal
- C_o is the minimum shunt capacitance specified for the crystal

I_{RMS} can be measured using a current probe (for example, Tektronix CT-6 or equivalent) placed on the leg of the crystal connected to XB with the oscillation circuit active. As shown in Figure 16, an external resistor, R_{lim} , can be used to limit the crystal drive level, if necessary. If the power dissipated in the selected crystal is higher than the drive level specified for the crystal with R_{lim} shorted, then a larger resistor value is mandatory to avoid overdriving the crystal. However, if the power dissipated in the crystal is less than the drive level with R_{lim} shorted, then a zero value for R_{lim} can be used. As a starting point, a suggested value for R_{lim} is 316 Ω .

If the crystal oscillator is not used, it is possible to drive the XA input with a single-ended external clock as shown in Figure 17 below. The input clock should be ac-coupled to the XA pin, which has an internally-generated input bias voltage, and the XB pin should be left floating. While XA provides an alternative input to multiplex an external clock, it is recommended to alternatively use either universal input (CLK0/CLK1) because the inputs offer higher operating frequency, better common-mode and power supply noise rejection, and greater performance over supply voltage and temperature variations.

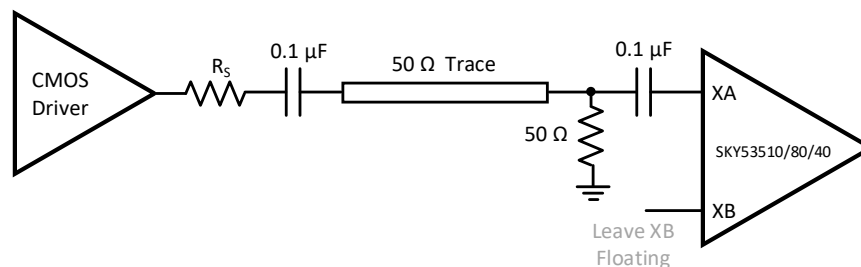


Figure 17. Driving XA with a Single-Ended Input Clock

3.3. Clock Output Termination

A single rising edge on the selected input clock is required for the output to then reflect the input source. All unused outputs should be left unconnected.

3.3.1. DC-Coupled Differential Output Driver Terminations

For dc-coupled operation of an LVDS driver, terminate with 100 Ω as close as possible to the LVDS receiver.

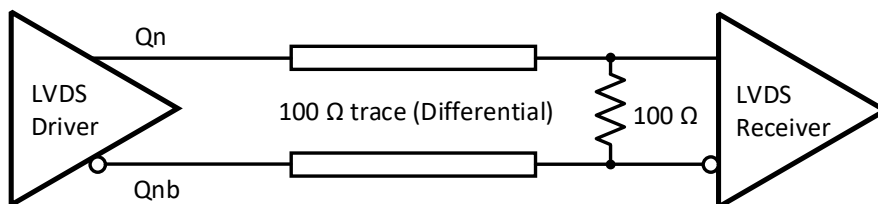


Figure 18. DC Coupled LVDS Clock Output Termination

For dc-coupled operation of an HCSL driver, terminate with 50 Ω to ground near the receiver as shown in Figure 19.

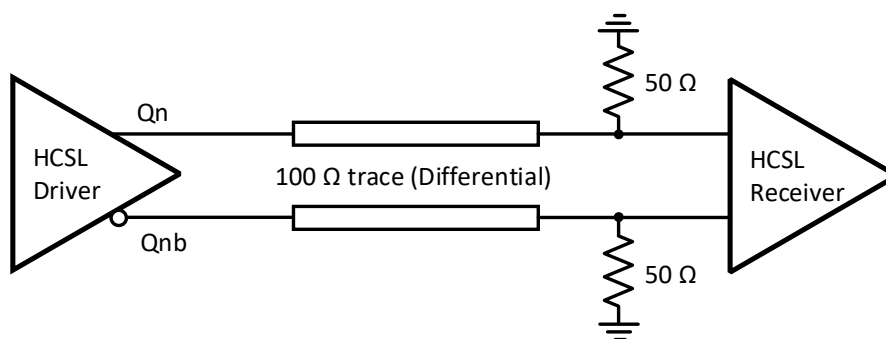


Figure 19. DC Coupled HCSL Clock Output Termination (Scheme 1)

It is also possible to terminate with 50 Ω to ground near the driver output. Series resistors, R_s , may be used to limit overshoot due to the fast transient current. Because HCSL drivers require a dc path to ground, ac coupling is not allowed between the output drivers and the 50 Ω termination resistors.

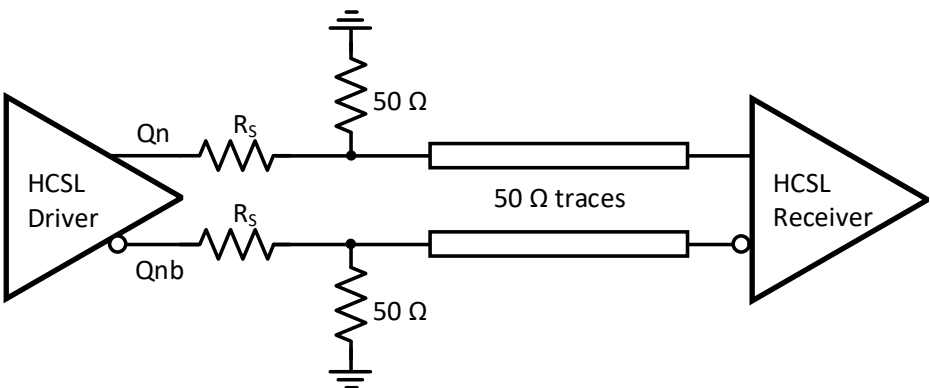


Figure 20. DC Coupled HCSL Clock Output Termination (Scheme 2)

For dc-coupled operation of an LVPECL driver, terminate with 50 Ω to $V_{DDO} - 2\text{ V}$, as noted in Figure 21 below. Alternatively, terminate with a Thevenin equivalent circuit as shown in Figure 22 on page 19 for V_{DDO} (output driver supply voltage) = 3.3 V and 2.5 V. In the Thevenin equivalent circuit, the resistor dividers set the output termination voltage (VTT) to $V_{DDO} - 2\text{ V}$.

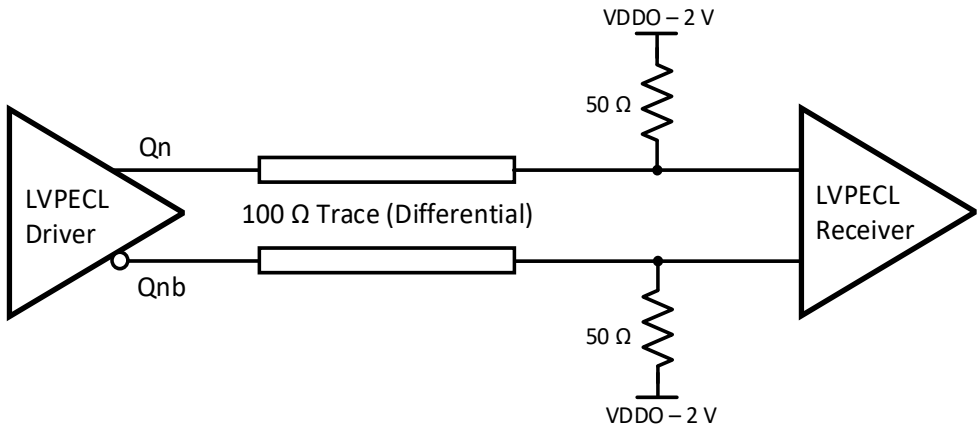


Figure 21. DC Coupled LVPECL Clock Output Termination

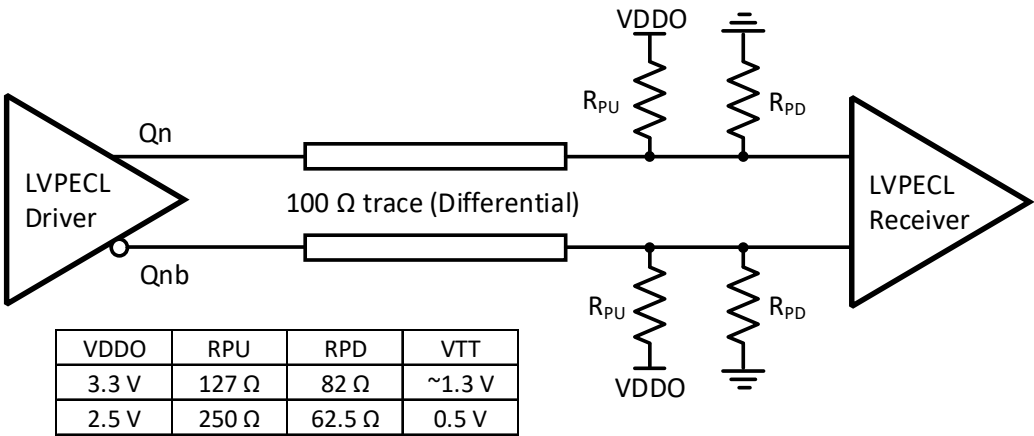


Figure 22. DC-Coupled LVPECL Clock Output Termination, Thevenin Equivalent

3.3.2. AC-Coupled Differential Output Driver Terminations

When driving differential receivers with an LVDS driver, the signal may be ac coupled by adding dc blocking capacitors; however the proper dc bias point needs to be established at both the driver side and the receiver side. The recommended termination scheme depends on whether the differential receiver has integrated termination resistors or not.

When driving a differential receiver without internal $100\ \Omega$ differential termination, the ac coupling capacitors should be placed between the load termination resistor and the receiver to allow a dc path for proper biasing of the LVDS driver. This is shown in Figure 23. The load termination resistor and ac-coupling capacitors should be placed as close as possible to the receiver inputs to minimize stub length. The receiver can be biased internally or externally to a reference voltage within the receiver's common mode input range through resistors in the kilo-ohm range.

When using ac coupling with LVDS outputs, there may be a start-up delay observed in the clock output due to capacitor charging. The examples in Figure 23 and Figure 24 use $0.1\ \mu\text{F}$ capacitors, but this value may be adjusted to meet the startup requirements for the particular application.

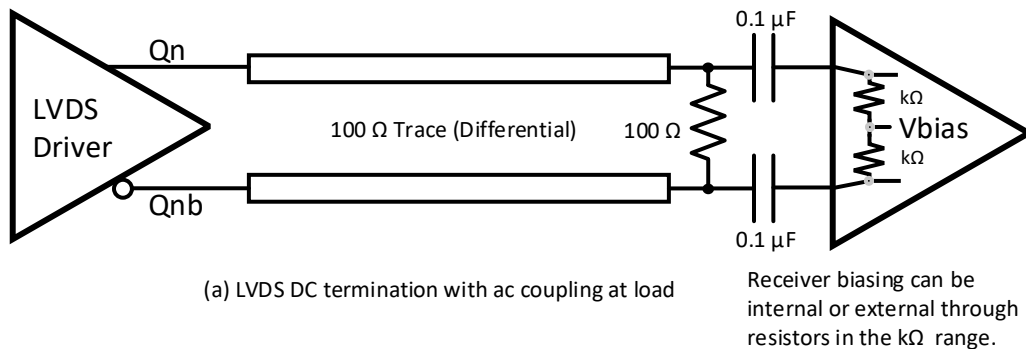


Figure 23. AC-Coupled LVDS Clock Output Coupled to Receivers without Internal $100\ \Omega$ Termination

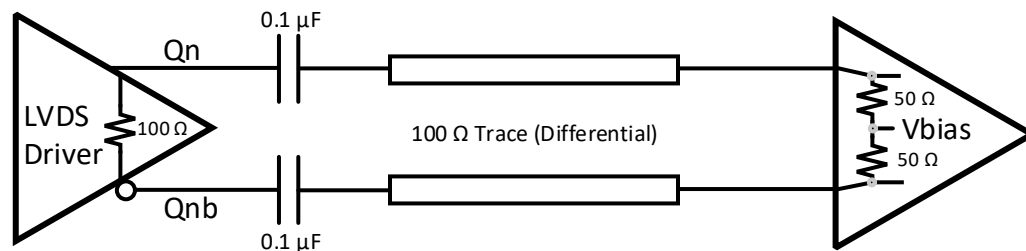


Figure 24. AC-Coupled LVDS Clock Output Coupled to Receivers with Internal $100\ \Omega$ Termination

LVPECL drivers require a dc path to ground. When ac coupling an LVPECL signal, use $160\ \Omega$ emitter resistors (or $91\ \Omega$ for $V_{DDO} = 2.5\ \text{V}$) close to the LVPECL driver to provide a dc path to ground as shown in Figure 25. For proper receiver operation, the signal should be biased to the dc bias level (common-mode voltage) specified by the receiver. The typical dc bias voltage (common-mode voltage) for LVPECL receivers is $2\ \text{V}$. Alternatively, a Thevenin equivalent circuit forms a valid termination as shown in Figure 25 for $V_{DDO} = 3.3\ \text{V}$ and $2.5\ \text{V}$.

Note: This Thevenin circuit is different from the dc-coupled example in Figure 22, since the voltage divider is setting the input common-mode voltage of the receiver.

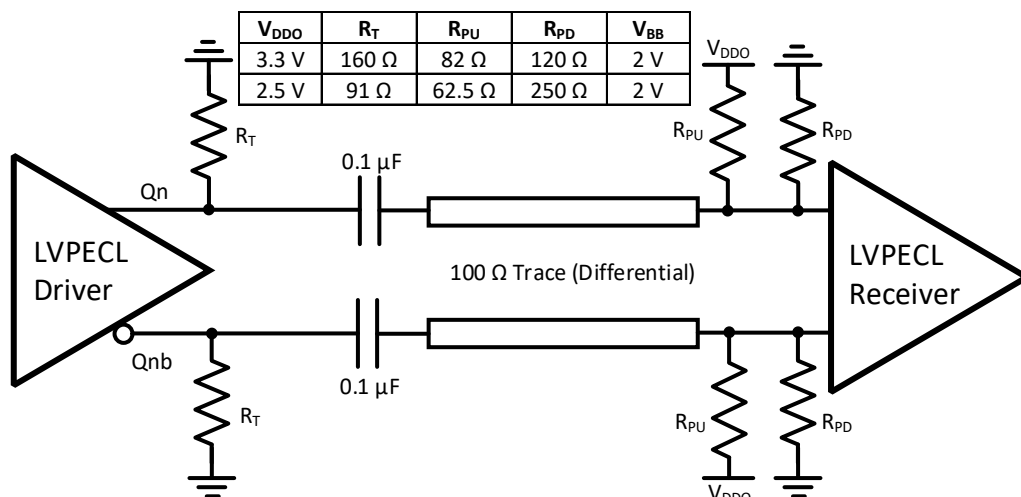


Figure 25. AC-Coupled LVPECL Clock Output Termination (Thevenin Equivalent)

A balun can be used with either LVDS or LVPECL drivers to convert the balanced, differential signal into an unbalanced, single-ended signal. It is possible to use an LVPECL driver as one or two separate 800 mV p-p single-ended signals. When dc-coupling one of the LVPECL drivers of a Qx/Qxb pair, ensure that the unused driver is properly terminated. When dc-coupling an LVPECL driver, the termination should be 50 Ω to $V_{DDO} - 2$ V as shown in Figure 26. The Thevenin equivalent circuit is also a valid termination as shown in Figure 27 for $V_{DDO} = 2.5$ V or 3.3 V.

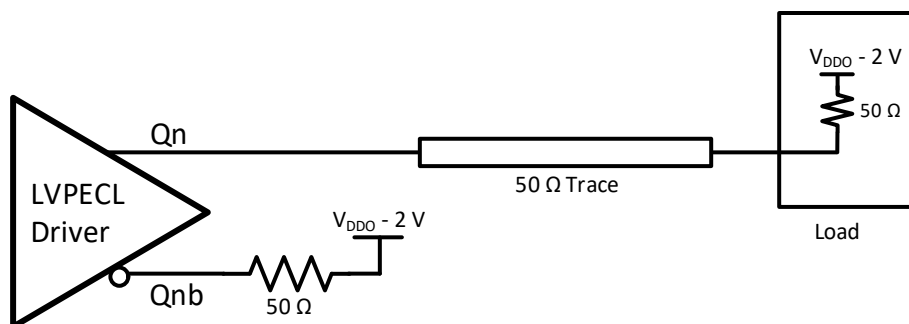


Figure 26. Single-Ended LVPECL Clock Output Termination, DC Coupling

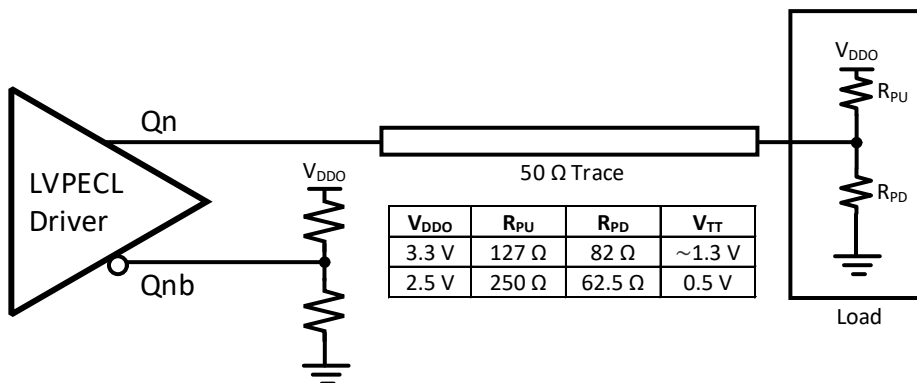


Figure 27. Single-Ended LVPECL Clock Output Termination, DC Coupling (Thevenin Equivalent)

When ac-coupling an LVPECL driver into a single-ended load, use a 160 Ω emitter resistor (or 91 Ω for $V_{DDO} = 2.5\text{ V}$) to provide a dc path to ground and ensure a 50 Ω termination with the proper dc bias level for the receiver. The typical dc bias voltage for LVPECL receivers is 2 V. If the companion driver is not used, it should be terminated with either a proper ac or dc termination. This latter example of ac coupling a single-ended LVPECL signal can be used to measure single-ended LVPECL performance using a spectrum analyzer or phase noise analyzer. When using most RF test equipment, a dc voltage level of 0 Vdc is required for safe and proper operation. The internal 50 Ω termination the test equipment correctly terminates the LVPECL driver being measured, as shown in Figure 28. When using only one LVPECL driver of a Qx/Qxb pair, be sure to properly terminate the unused driver.

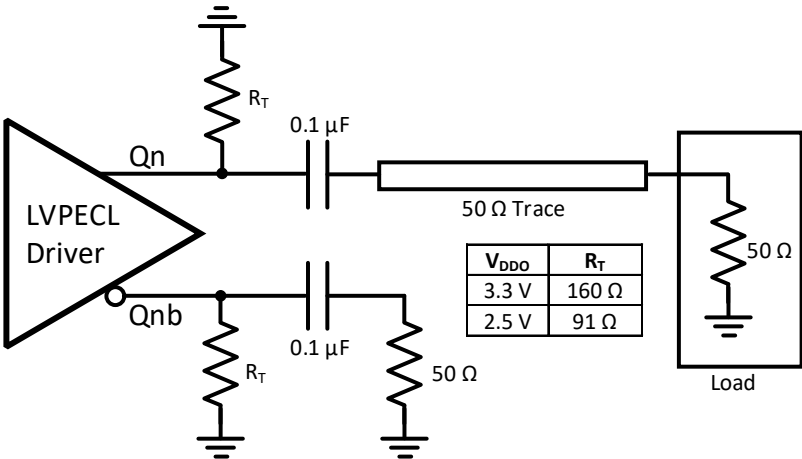


Figure 28. Single-Ended LVPECL Clock Output Termination (AC Coupling)

4. Power Supply (V_{DD} and V_{DDOx})

The device includes separate core (V_{DD}) and output driver supplies (V_{DDOx}). This feature allows the V_{DDO} to operate at a lower voltage than the core V_{DD} reducing current consumption in mixed supply operations. The core V_{DD} supports 3.3, 2.5, or 1.8 V. Control signals, such as CLK_SEL[1:0], SFOUTx[1:0], and OE_REF, are in the V_{DD} domain. Each output bank has its own V_{DDOx} supply, supporting 3.3, 2.5, or 1.8 V.

4.1. Power Supply Sequencing

All power supplies must ramp in a monotonic, linear fashion. When powering the V_{DD} and V_{DDOx} pins from separate supply rails, it is recommended for the supplies to reach their regulation point at approximately the same time while ramping up, or reach ground potential at the same time while ramping down. Clock inputs should not be driven until V_{DD} has reached the recommended minimum levels. V_{DD} must be equal to, or greater than, V_{DDOx} .

5. Electrical Specifications

Table 9. Absolute Maximum Ratings¹

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Storage temperature	T_S		-55	—	150	°C
Supply voltage	$V_{DD}, V_{DDOA}, V_{DDOB}, V_{DDOC}$		-0.5	—	3.8	V
Input voltage	V_{IN}		-0.5	—	$V_{DD} + 0.3$	V
Output voltage	V_{OUT}		—	—	$V_{DDOx} + 0.3$	V
ESD sensitivity	HBM	HBM, 100 pF, 1.5 kΩ	—	—	2000	V
ESD sensitivity	CDM		—	-	500	V
Peak soldering reflow temperature	T_{PEAK}	Pb-Free; Solder reflow profile per JEDEC J-STD-020	—	—	260	°C
Maximum junction temperature	T_J		—	—	125	°C

1. Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.

ESD Handling: Industry-standard ESD handling precautions must be adhered to at all times to avoid damage to this device.

Table 10. Recommended Operating Conditions

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Ambient operating temperature	T_A	JEDEC Board, 4-layer	-40	—	85	°C
		8-layer Board	-40	—	95	°C
Board operating temperature	T_B		-40	—	105	°C
Core supply voltage range ¹	V_{DD}	LVC MOS, S-LVDS, HCSL input clock(s)	1.71	1.8	1.89	V
		LVC MOS, LVDS, LVPECL, HCSL input clock(s)	2.37	2.5	2.63	V
		LVC MOS, LVDS, LVPECL, HCSL input clock(s)	3.13	3.3	3.47	V
Output buffer supply voltage range	V_{DDOA}, V_{DDOB}	S-LVDS, HCSL	1.71	1.8	1.89	V
		LVDS, LVPECL, HCSL	2.37	2.5	2.63	V
		LVDS, LVPECL, HCSL	3.13	3.3	3.47	V
Reference output supply voltage range	V_{DDOC}	LVC MOS	1.71	1.8	1.89	V
			2.37	2.5	2.63	V
			3.13	3.3	3.47	V

1. Core supply V_{DD} and output buffer supplies V_{DDOx} are independent. $V_{DDOx} \leq V_{DD}$.

Table 11. Input Clock Specifications(V_{DD} = 1.8 V ± 5%, 2.5 V ± 5%, or 3.3 V ± 5%, T_A = -40 to 95 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Differential input common-mode voltage	V _{CM}	V _{DD} = 2.5 V ± 5%, 3.3 V ± 5%	0.25	—	V _{DD} - 1.1	V
		V _{DD} = 1.8 V ± 5%	0.25	—	V _{DD} - 0.8	V
Differential input swing (peak-to-peak)	V _{IN}	V _{DD} = 1.8 V ± 5%, 2.5 V ± 5%, 3.3 V ± 5%	0.20	—	2.2	V
Input slew rate ¹	SR	Differential input	3.0	—	—	V/ns
		Single-ended input	1.0	—	—	V/ns
LVC MOS input high voltage	V _{IH}		V _{DD} × 0.7	—	—	V
LVC MOS input low voltage	V _{IL}		—	—	V _{DD} × 0.3	V
Input frequency	F _{IN}	CLK0/CLK0b and CLK1/CLK1b, Differential Input	DC	—	3100	MHz
		CLK0 and CLK1 pins, Single Ended Input	DC	—	250	MHz
		XA pin (driven single-ended, ac) input clock duty cycle 50%, output clock duty cycle 45% min/55% max.	0.1	—	100	MHz
		XA pin (driven single-ended, ac) input clock duty cycle 50%, output clock duty cycle 40% min/60% max.	100	—	250	MHz
Crystal frequency	F _{XTAL}	Fundamental mode crystal ²	24		54	MHz
Input capacitance	C _{IN}	CLK0 and CLK1 pins with respect to GND	—	2.5	—	pF
		XA with respect to GND	—	4	—	pF

1. Required to meet prop delay and additive jitter specifications (20-80%). The device functions with a slower slew rate but may have increased jitter.

2. Max Crystal ESR for 24 MHz = 50 Ω, 54 MHz = 25 Ω; C₁ = 8 pF, C₀ ≤ 2 pF; from Figure 16 on page 17: C_{1(XA)} = 6.8 pF; C_{2(XB)} = 8 pF. These values are based on the PCB layout used for characterization; equations for calculating these values for other layouts are provided in AN1405.**Table 12. DC Common Characteristics**(V_{DD}/V_{DDOx} = 1.8 V ± 5%, 2.5 V ± 5%, or 3.3 V ± 5%, T_A = -40 to 95 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Supply current	I _{DD}	3.3 V, HCSL, LVDS, or LVPECL	—	92	120	mA
		2.5 V, HCSL, LVDS, or LVPECL	—	87	115	mA
		1.8 V, HCSL, LVDS	—	78	110	mA
Output buffer supply current (per clock output) at 156.25 MHz (differential)	I _{DDOx}	LVPECL (3.3 V)	—	32	—	mA
		LVDS (3.3 V)	—	10	—	mA
		HCSL(3.3 V)	—	25	—	mA
REFOUT buffer supply current at 200 MHz	I _{DDREF}	CMOS (1.8 V) ¹	—	8	—	mA
		CMOS (2.5 V) ¹	—	12	—	mA
		CMOS (3.3 V) ¹	—	18	—	mA
Input high voltage	V _{IH}	SFOUTx, CLK_SELx, OE_REF	0.7 × V _{DD}	—	—	V
Input low voltage	V _{IL}	SFOUTx, CLK_SELx, OE_REF	—	—	0.3 × V _{DD}	V
Internal pull-down resistor	R _{PD}	SFOUTx, CLK_SELx, OE_REF	—	45	—	kΩ

1. Output capacitance load ≤ 5 pF for V_{DDOx} = 1.8 V, C_L ≤ 10 pF for V_{DDOx} = 2.5 V, C_L ≤ 15 pF for V_{DDOx} = 3.3 V

Table 13. LVPECL Output Characteristics¹(V_{DDOA/B} = 2.5 V ± 5% or 3.3 V ± 5%, T_A = -40 to 95 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Output frequency	F _{OUT}	Full amplitude, V _{OD} ≥ 600 mV, V _{DDOx} = 2.5 V	DC	—	1275	MHz
		Full amplitude, V _{OD} ≥ 600 mV, V _{DDOx} = 3.3 V	DC	—	1325	MHz
		67% amplitude, V _{OD} ≥ 400 mV, V _{DDOx} = 2.5 V	1275	—	2350	MHz
		67% amplitude, V _{OD} ≥ 400 mV, V _{DDOx} = 3.3 V	1325	—	3100	MHz
Output rise/fall time	t _R /t _F	LVPECL, 20/80%, 3.3 V	—	200	225	ps
		LVPECL, 20/80%, 2.5 V	—	185	220	ps
Output dc common mode voltage	V _{CMO}		V _{DDOx} - 1.5	V _{DDOx} - 1.3	V _{DDOx} - 1.0	V
Output high voltage	V _{OH}	T _A = 25 °C, dc measurement, R _p = 50 Ω to V _{DDOx} - 2 V	V _{DDOx} - 1.2	V _{DDOx} - 0.9	V _{DDOx} - 0.6	V
Output low voltage	V _{OL}		V _{DDOx} - 2.0	V _{DDOx} - 1.7	V _{DDOx} - 1.4	V
Output voltage swing	V _{OD}		600	800	1000	mV
Output duty cycle	DC	Input clock must have 50% duty cycle	45	50	55	%
Additive noise floor f _{offset} ≥ 10 MHz	NF	F _{OUT} = 156.25 MHz	—	-166	—	dBc/Hz
Propagation delay	T _{PLH} , T _{PHL}	CLK0 or CLK1 input pins to output driver pins	575	765	1070	ps

1. Unused outputs should be left floating. Do not short unused outputs to ground.

Table 14. LVDS Output Characteristics¹(V_{DDOA/B} = 1.8 V ± 5%, 2.5 V ± 5%, or 3.3 V ± 5%, T_A = -40 to 95 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Output frequency	F _{OUT}	Full amplitude, V _{OD} ≥ 247 mV	0	—	2200	MHz
		67% amplitude, V _{OD} ≥ 167 mV	2200	—	3000	MHz
Delta V _{OD}	ΔV _{OD}				50	mV
Offset voltage (V _{DDOx} = 2.5 V or 3.3 V)	V _{OS}	V _{DDOx} = 2.37 to 2.63 V, 3.13 to 3.47 V, R _L = 100 Ω across Qn and Qnb	1.15	1.2	1.25	V
Offset voltage (V _{DDOx} = 1.8 V)		V _{DDOx} = 1.71 to 1.89 V, R _L = 100 Ω across Qn and Qnb	0.85	0.9	0.95	V
Delta V _{OS}	ΔV _{OS}				50	mV
Output rise/fall time	t _R , t _F	LVDS, 20/80%	—	200	260	ps
Output voltage swing	V _{OD}	R _L = 100 Ω across Qn and Qnb	247	390	454	mV
Output duty cycle	DC	F _{OUT} ≤ 3000 MHz, Input clock must have 50% duty cycle, 800 mV V _{IN} , ac-coupled	45	50	55	%
Additive noise floor, f _{offset} ≥ 10 MHz	NF	F _{OUT} = 156.25 MHz	—	-165	—	dBc/Hz
Propagation delay	T _{PLH} , T _{PHL}	CLK0 or CLK1 input pins to output driver pins	560	825	1145	ps

1. Unused outputs should be left floating. Do not short unused outputs to ground.

Table 15. HCSL Output Characteristics^{1,2}(V_{DDOA/B} = 1.8 V ± 5%, 2.5 V ± 5%, or 3.3 V ± 5%, T_A = -40 to 95 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Output frequency	F _{OUT}	Full amplitude	0	—	650	MHz
		67% amplitude	650	—	800	MHz
Output rise/fall time	t _R /t _F	20/80%	—	300	400	ps
Single-ended output swing	V _{SE}	DC measurement, R _L = 50 Ω to ground	0.60	0.80	1.0	V
Output duty cycle	DC	Input clock must have 50% duty cycle	45	50	55	%
Additive noise floor, f _{offset} >10 MHz	N _{FLOOR}	F _{OUT} = 156.25 MHz	—	-166	—	dBc/Hz
Propagation delay	T _{PLH} , T _{PHL}	CLK0 or CLK1 input pins to output driver pins	575	820	1110	ps
Rise-Fall matching	R/F _{Match}	100 MHz PCIe Reference Clock as source, with/without spread spectrum ³	—	10	—	%
Variation of fall time over all falling clock edges	T _{Fall_Delta}		—	20	—	ps
Variation of rise time over all rising clock edges	T _{Rise_Delta}		—	15	—	ps
Absolute crossing point voltage (V)	V _{Cross}		0.33	0.4	0.48	V
Variation of crossing point over all rising clock edges	V _{Cross_Delta}		—	40	—	mV
Overshoot voltage	V _{Ovs}		-20	—	40	mV
Undershoot voltage	V _{Uds}		-20	—	40	mV
Ring-back voltage	V _{Rb}		—	—	80	mV

1. Unused outputs should be left floating. Do not short unused outputs to ground.

2. DC-coupled HCSL Clock Output Termination. See [Figure 19 on page 18](#).

3. Parameters measured with Skyworks PCI Express Clock Jitter Tool on a 100 MHz HCSL load-terminated clock waveform with/without spread spectrum, over at least 100,000 clock periods.

Table 16. REFOUT Output Characteristics (LVCMOS)(V_{DDOC} = 1.8 V ± 5%, 2.5 V ± 5%, or 3.3 V ± 5%, T_A = -40 to 95 °C).

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Noise floor f _{offset} ≥ 10 MHz	NF	V _{DDOC} = 3.3 V, F _{out} = 156.25 MHz	—	-164	—	dBc/Hz
REFOUT output enable time ¹	T _{EN_REF}	F ≤ 250 MHz	—	3	4	Clock cycles
REFOUT output disable time ¹	T _{DIS_REF}	F ≤ 250 MHz	—	3	4	Clock cycles
Output frequency	F _{OUT}	REFOUT	0	—	250	MHz
Output voltage high	V _{OH}	I _{OUT} = -1 mA	0.9 × V _{DDOC}	—	—	V
		I _{OUT} = -10 mA	0.75 × V _{DDOC}	—	—	V
Output voltage low	V _{OL}	I _{OUT} = 1 mA	—	—	0.1 × V _{DDOC}	V
		I _{OUT} = 10 mA	—	—	0.25 × V _{DDOC}	V
Output rise/fall time	t _R /t _F	20%/80%, 1.8 V, C _L = 5 pF, 50 Ω load impedance	—	640	750	ps
		20%/80%, 2.5 V, C _L = 10 pF, 50 Ω load impedance	—	775	910	ps
		20%/80%, 3.3 V, C _L = 15 pF, 50 Ω load impedance	—	1030	1220	ps
Output duty cycle	DC	C _L = 5 pF, input clock must have 50% duty cycle	45	50	55	%
Propagation delay	T _{PLH} , T _{PHL}	V _{DD} = V _{DDOC} = 1.8 V, C _L = 5 pF V _{DD} = V _{DDOC} = 2.5 V, C _L = 10 pF V _{DD} = V _{DDOC} = 3.3 V, C _L = 15 pF CLK0 or CLK1 input pins to REFOUT pin 50 Ω load impedance	1200	1825	2370	ps

1. Four clock cycles are only possible when the OE_REF enable signal is asynchronous to the clock input signal.

Table 17. Common Output Characteristics(V_{DD}, V_{DDOx}/B/C = 1.8 V ± 5%, 2.5 V ± 5%, or 3.3 V ± 5%, T_A = -40 to 95 °C)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Buffer mode startup time	T _{SBUF}	From V _{DDOx} = 1.55 V to outputs enabled	—	—	30	ms
Crystal mode startup time ¹	T _{SOSC}	From V _{DD} = 1.55 V to outputs enabled	—	—	100	ms
Crystal mode VDD ramp ²	T _{ROSC}	From V _{DD} = 1.55 V to outputs enabled	—	—	26	ms
Crystal mode jitter	T _{JXO}	24 MHz fundamental crystal, VDD = 1.8 V ± 5% or 2.5 V ± 5%, 10 kHz to 1 MHz integration bandwidth	—	96	125	fs
		24 MHz fundamental crystal, VDD = 3.3 V ± 5%, 10 kHz to 1 MHz integration bandwidth	—	67	110	fs
		54 MHz fundamental crystal, VDD = 1.8 V ± 5% or 2.5 V ± 5%, 12 kHz to 20 MHz integration bandwidth	—	150	185	fs
		54 MHz fundamental crystal, VDD = 3.3 V ± 5%, 12 kHz to 20 MHz integration bandwidth	—	100	130	fs
Output enable time ³	T _{EN}	Hi-Z to LVPECL/LVDS/HCSL	—	—	15	μs
Output disable time	T _{DIS}	LVPECL/LVDS/HCSL to Hi-Z	—	15	50	ns
Output-to-output skew	T _{Skew}	HCSL	—	3	50	ps
		LVDS	—	3	50	ps
		LVPECL	—	3	50	ps
Supply voltage ramp rate	T _{VDD}	Fastest VDD ramp rate allowed on startup	—	—	100	V/ms
Part-to-part skew	T _{PS}	Same differential format, load, temp, voltage, and output channel between devices	—	17	110	ps
Power supply noise rejection ⁴ F _{IN} = 156.25 MHz	PSNR	HCSL	—	-75	—	dBc
		LVDS	—	-75	—	dBc
		LVPECL	—	-69	—	dBc
Power supply noise rejection ⁴ F _{IN} = 312.5 MHz	PSNR	HCSL	—	-69	—	dBc
		LVDS	—	-69	—	dBc
		LVPECL	—	-63	—	dBc
Input-to-output crosstalk, CLKIN0 to CLKIN1	XTALK	F _{OFFSET} ≥ 50 kHz, Input = LVDS, F _{IN} = 100 MHz	—	-78.5	—	dBc
		F _{OFFSET} ≥ 50 kHz, Input = LVDS, F _{IN} = 200 MHz	—	-82.5	—	dBc
		F _{OFFSET} ≥ 50 kHz, Input = LVDS, F _{IN} = 500 MHz	—	-90	—	dBc
		F _{OFFSET} ≥ 50 kHz, Input = LVDS, F _{IN} = 1000 MHz	—	-78.5	—	dBc

1. Applies any time the input clock source is switched from CLK0/1 to XTAL or ac-coupled XA mode.
2. Applies only when powering up while the crystal oscillator input is selected.
3. When enabling outputs from Hi-Z, the first edge out will be a rising edge and the first period out will be a full period. Output frequencies <1 MHz may add up to one full period to the enable time given here.
4. Sine-wave noise added to VDDOx (100 mVpp at VDDOx = 3.3 V), and noise spur amplitude measured at 100 kHz frequency offset from carrier. See "AN491: Power Supply Rejection for Low-Jitter Clocks" for further details.

Table 18. Additive Jitter (Differential Clock Input)(V_{DD}, V_{DDOx} = 1.8 V ±5%, 2.5 V ±5%, or 3.3 V ±5%, T_A = -40 to 95 °C)

Clock Frequency (MHz) ^{1,2}	VDD Nominal	Output Format	Additive Jitter, fs RMS											
			10 kHz to 1 MHz ³		10 kHz to 20 MHz ³		12 kHz to 20 MHz ³		1 MHz to 20 MHz ³		12 kHz to 20 MHz, 4 MHz HPF ³		12 kHz to 20 MHz, 4 MHz to 16 MHz BPF ³	
			Typ	Max	Typ	Max	Typ	Max	Typ	Max	Typ	Max	Typ	Max
156.25 MHz	1.8 V, 2.5 V, 3.3 V	HCSL	11	18	37	49	37	49	35	47	31	41	24	33
	1.8 V, 2.5 V, 3.3 V	LVDS	13	19	41	52	41	52	39	50	34	43	27	35
	2.5 V, 3.3 V	LVPECL	11	17	35	47	35	47	34	45	29	39	23	31
625 MHz	1.8 V, 2.5 V, 3.3 V	HCSL	9	14	18	26	18	26	16	23	14	20	11	16
	1.8 V, 2.5 V, 3.3 V	LVDS	9	14	19	28	19	28	16	24	14	21	11	17
	2.5 V, 3.3 V	LVPECL	9	14	18	26	18	26	16	23	14	20	11	16

- For best additive jitter results, use the fastest input clock slew rate possible. See “AN766: Understanding and Optimizing Clock Buffer's Additive Jitter Performance” for more information.
- AC-coupled differential inputs, differential amplitude V_{IN} = 0.5 V (single-ended, peak-to-peak), 3 V/ns (20% to 80% slew rate).
- Measured differentially using a balun at the phase noise analyzer input.

Table 19. Additive Jitter (Single-Ended Clock Input)(V_{DD}, V_{DDOx} = 1.8 V ±5%, 2.5 V ±5%, or 3.3 V ±5%, T_A = -40 to 95 °C)

Clock Frequency (MHz) ^{1,2,3}	VDD Nominal	Output Format	Additive Jitter, fs RMS											
			10 kHz to 1 MHz ⁴		10 kHz to 20 MHz ⁴		12 kHz to 20 MHz ⁴		1 MHz to 20 MHz ⁴		12 kHz to 20 MHz, 4 MHz HPF ⁴		12 kHz to 20 MHz, 4 MHz to 16 MHz BPF ⁴	
			Typ	Max	Typ	Max	Typ	Max	Typ	Max	Typ	Max	Typ	Max
156.25 MHz	1.8 V, 2.5 V, 3.3 V	HCSL	17	30	45	72	45	72	42	76	36	65	29	53
	1.8 V, 2.5 V, 3.3 V	LVDS	21	31	64	85	64	85	61	82	53	72	43	60
	2.5 V, 3.3 V	LVPECL	17	26	45	78	45	78	42	66	36	65	29	53

- For best additive jitter results, use the fastest input clock slew rate possible. See “AN766: Understanding and Optimizing Clock Buffer's Additive Jitter Performance” for more information.
- Measurements taken using input clock termination noted in Figure 13 on page 15 and Figure 15 on page 16.
- Single-ended clock input, differential amplitude V_{IN} = 2.18 V for VDD = 2.5 V and 3.3 V; V_{IN} = 1.2 V for VDD = 1.8 V (single-ended, peak-to-peak), 1 V/ns (20% to 80% slew rate).
- Measured differentially using a balun at the phase noise analyzer input.

Table 20. 100 MHz PCIe Jitter Performance Characteristics (with/without Spread Spectrum)¹ $V_{DD} = V_{DDOx} = 1.8\text{ V} \pm 5\%$, $2.5\text{ V} \pm 5\%$, or $3.3\text{ V} \pm 5\%$, $T_A = -40\text{ to }95\text{ }^{\circ}\text{C}$

Parameter	Comment	Min	Typ	Max	PCI-SIG Limit ²	Units
100 MHz PCIe common-clock jitter performance ³	Gen 1 (2.5GT/s)	—	13	23	86	ps PTP
	Gen 2 (5GT/s) low band	—	5	6	3000	fs RMS
	Gen 2 (5GT/s) high band	—	68	139	3100	fs RMS
	Gen 3 (8GT/s)	—	14	32	1000	fs RMS
	Gen 4 (16GT/s)	—	14	32	500	fs RMS
	Gen 5 (32GT/s)	—	4	9	150	fs RMS
	Gen 6 (64GT/s)	—	3	7	100	fs RMS
	Gen 7 (128GT/s)	—	2	5	67	fs RMS
100 MHz PCIe separate reference clock jitter performance ^{2,3}	Gen 2 (5GT/s) low band	—	1	1	2120	fs RMS
	Gen 2 (5GT/s) high band	—	43	99	2190	fs RMS
	Gen 3 (8GT/s)	—	23	47	707	fs RMS
	Gen 4 (16GT/s)	—	25	49	495	fs RMS
	Gen 5 (32GT/s)	—	5	11	177	fs RMS
	Gen 6 (64GT/s)	—	5	10	106	fs RMS
	Gen 7 (128GT/s)	—	3	7	71	fs RMS

- Results obtained from using a Skyworks Si5361 Jitter Attenuator as a source clock. Clock parameters: 100 MHz HCSL clock, with/without spread spectrum, 4 V/ns slew rate, 800 mVpp se. Jitter specifications derived using Skyworks PCI Express Clock Jitter Tool v.7.1.
- PCI-SIG does not specify a jitter limit for separate reference clock architectures. Instead, the PCI-SIG specified simulation limit can be split evenly between transmitter and receiver clocks by dividing by the square root of 2, since their jitter is uncorrelated.
- Jitter integration as specified by PCI-SIG in the PCI Express® Base Specification Revision 7.0.

Table 21. Thermal Conditions

Package	Parameter	Symbol	Test Condition	Typical Value		Unit
				JEDEC ¹	EVB ²	
7 x 7 mm QFN	Thermal resistance (junction to ambient)	θ_{JA}	Still air	26.0	10.1	°C/W
			1 m/s	21.7	8.8	°C/W
			2 m/s	20.8	8.7	°C/W
	Thermal resistance (junction to board)	θ_{JB}	Still air	10.7	3.5	°C/W
	Thermal resistance (junction to case)	θ_{JC}	Still air	0.4	0.6	°C/W
6 x 6 mm QFN	Thermal resistance (junction to ambient)	θ_{JA}	Still air	24.8	11.8	°C/W
			1 m/s	18.8	9.3	°C/W
			2 m/s	17.8	9.1	°C/W
	Thermal resistance (junction to board)	θ_{JB}	Still air	8.9	4.4	°C/W
	Thermal resistance (junction to case)	θ_{JC}	Still air	0.4	0.5	°C/W
5 x 5 mm QFN	Thermal resistance (junction to ambient)	θ_{JA}	Still air	31.5	11.6	°C/W
			1 m/s	26.6	10.2	°C/W
			2 m/s	25.5	10.1	°C/W
	Thermal resistance (junction to board)	θ_{JB}	Still air	14.0	4.4	°C/W
	Thermal resistance (junction to case)	θ_{JC}	Still air	0.5	0.6	°C/W

1. Based on PCB with dimension 4"x 5", thickness of 1.6 mm, with two layers of copper, epad has 16x vias (12 mil).

2. Based on PCB with dimension 9"x 9", thickness of 1.6 mm, with eight layers of copper, epad has 49x vias (8 mil).

6. Typical Performance Characteristics

Unless otherwise specified: $V_{DD} = 3.3\text{ V}$, $V_{DDOx} = 3.3\text{ V}$, $T_A = 25\text{ }^{\circ}\text{C}$, input clock driven differentially, input slew rate $\geq 3\text{ V/ns}$.

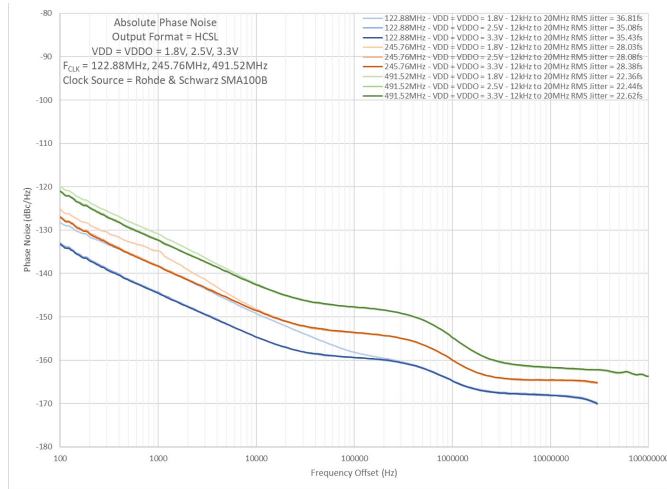


Figure 29. Absolute Phase Noise Differential Input (HCSL: 491.52 MHz, 245.76 MHz, 122.88 MHz)

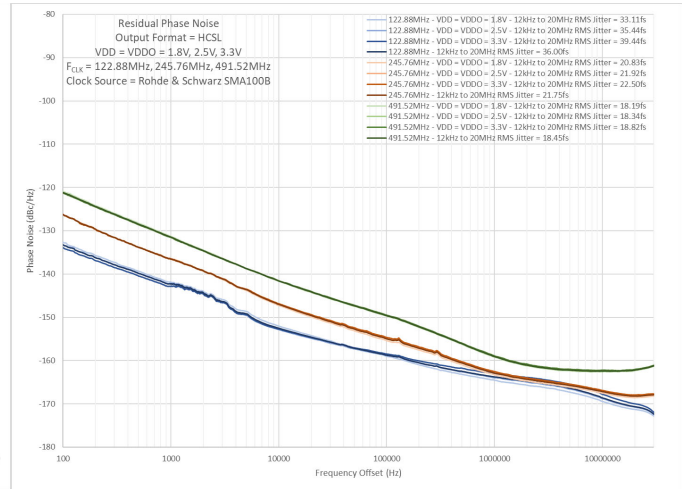


Figure 30. Residual Phase Noise Differential Input (HCSL: 491.52 MHz, 245.76 MHz, 122.88 MHz)

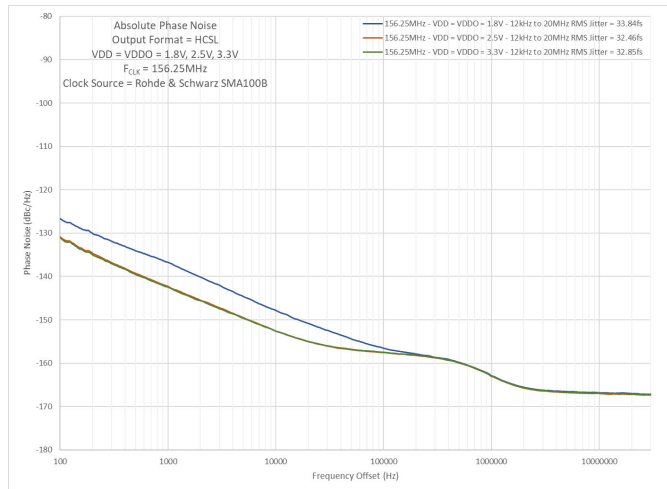


Figure 31. Absolute Phase Noise Differential Input (HCSL: 156.25 MHz)

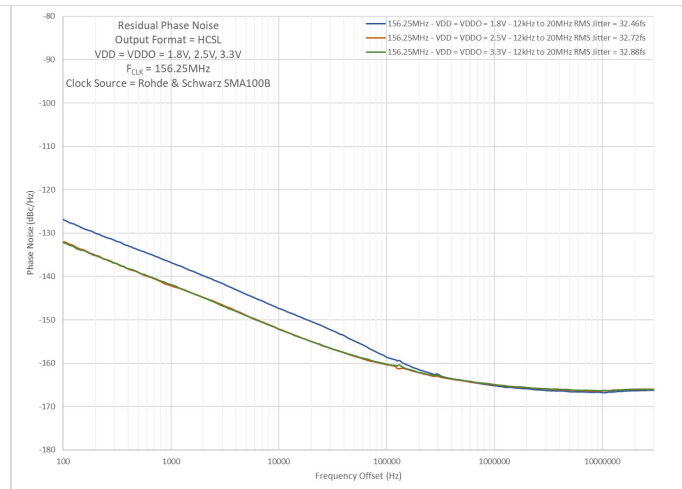


Figure 32. Residual Phase Noise Differential Input (HCSL: 156.25 MHz)

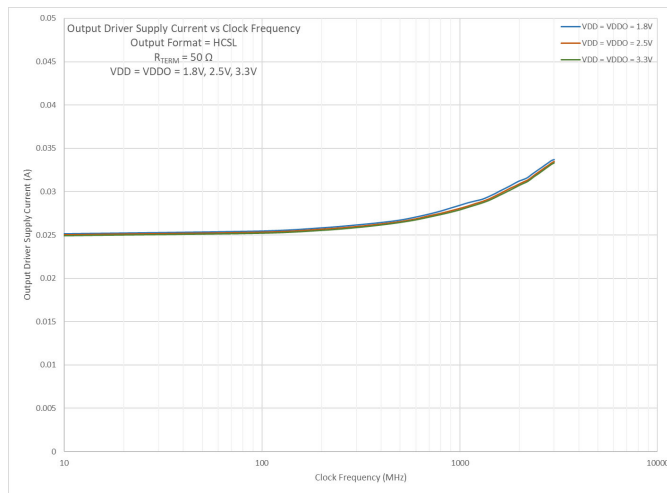


Figure 33. Supply Current Per Output vs. Frequency (HCSL)

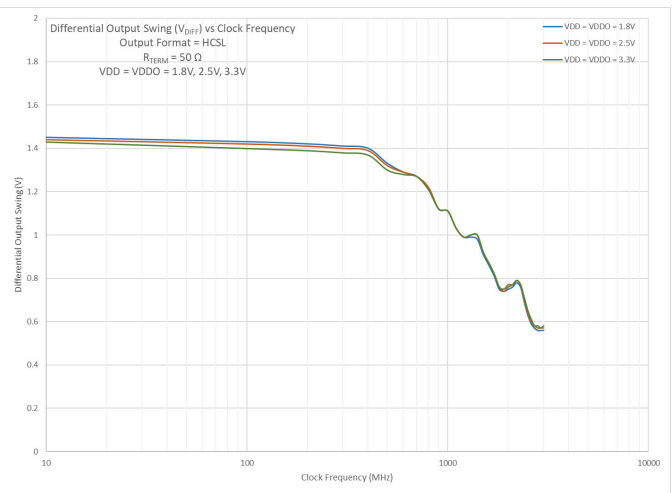


Figure 34. Differential Output Voltage Swing vs. Frequency (1.8 V, 2.5 V, 3.3 V HCSL)

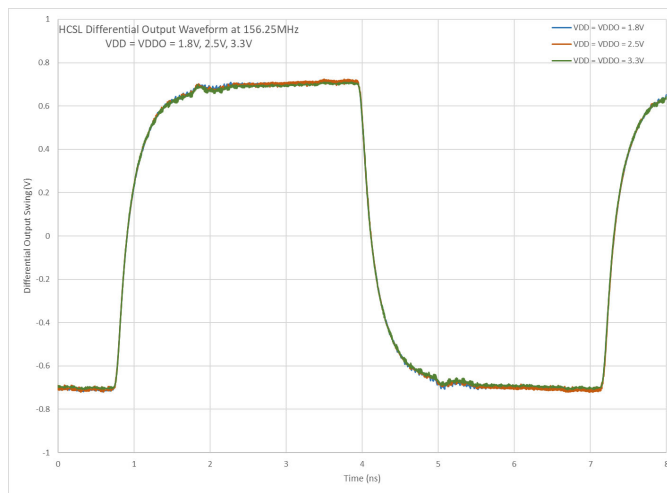


Figure 35. HCSL Differential Output Waveform (156.25 MHz)

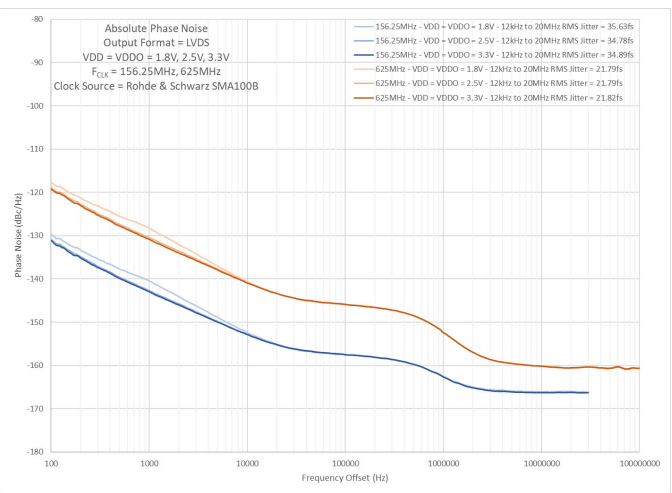


Figure 36. Absolute Phase Noise Differential Input (LVDS: 625 MHz, 156.25 MHz)

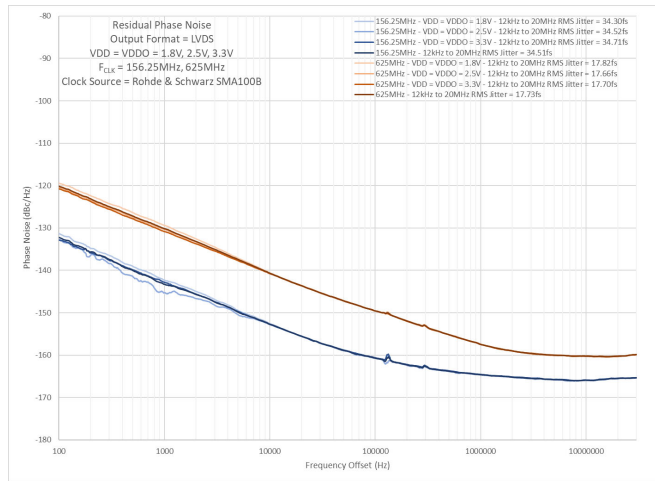


Figure 37. Residual Phase Noise Differential Input (LVDS: 625 MHz, 156.25 MHz)

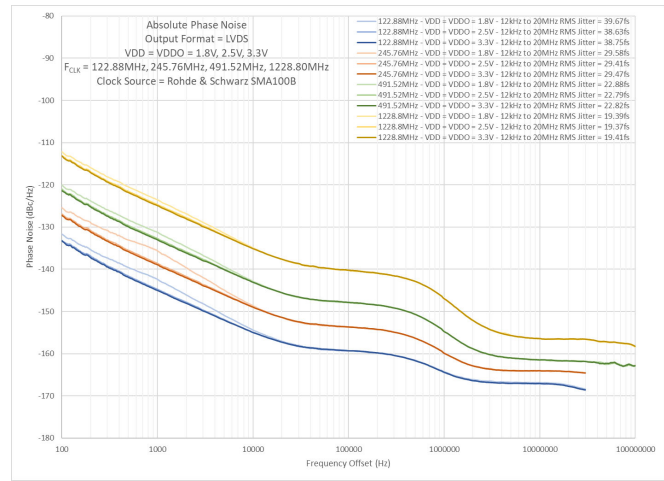


Figure 38. Absolute Phase Noise Differential Input (LVDS: 2457.6 MHz, 1228.80 MHz, 491.52 MHz, 122.88 MHz)

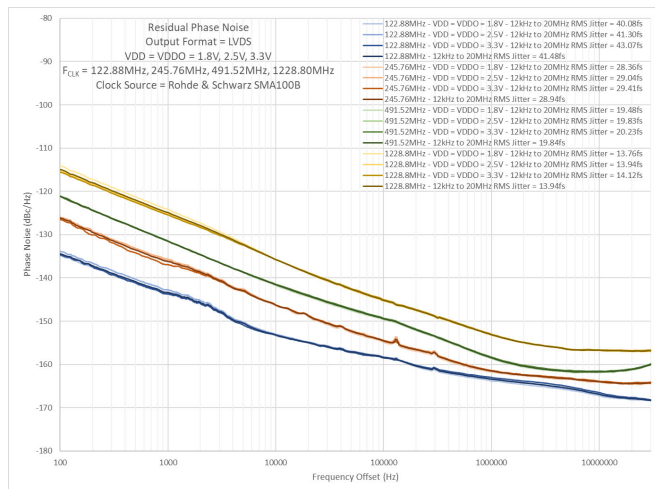


Figure 39. Residual Phase Noise Differential Input (LVDS: 2457.6 MHz, 1228.80 MHz, 491.52 MHz, 122.88 MHz)

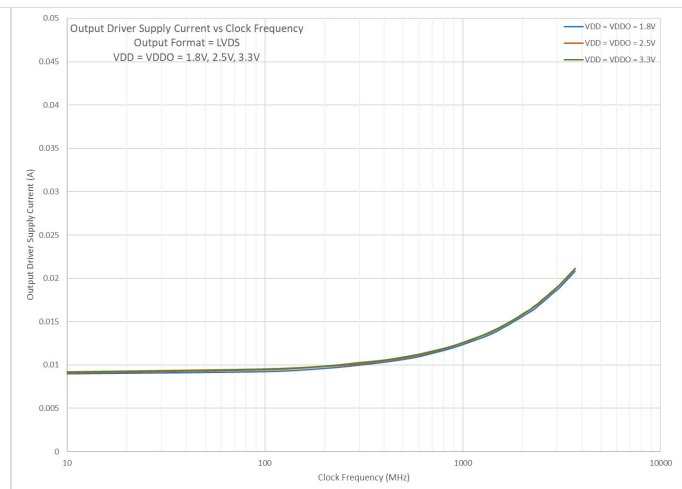


Figure 40. Supply Current Per Output vs. Frequency (LVDS)

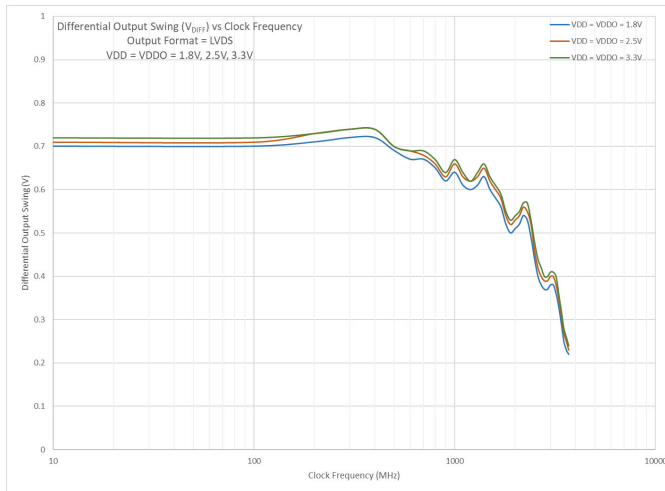


Figure 41. Differential Output Voltage Swing vs. Frequency (1.8 V, 2.5 V, 3.3 V LVDS)

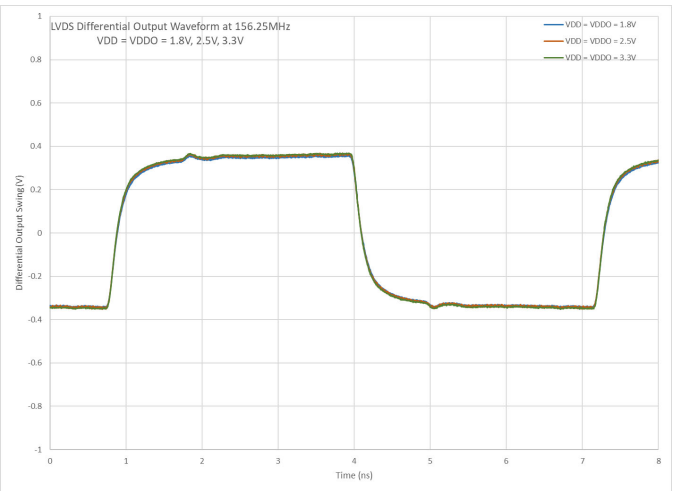


Figure 42. LVDS Differential Output Waveform (156.25 MHz)

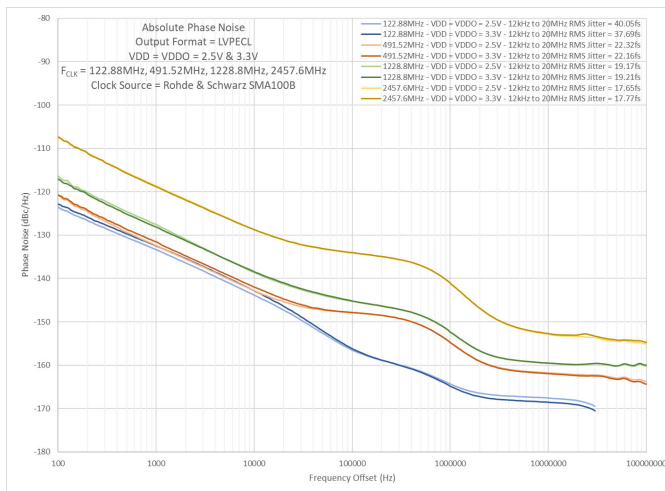


Figure 43. Absolute Phase Noise Differential Input (LVPECL: 2457.6 MHz, 1228.80 MHz, 491.52 MHz, 122.88 MHz)

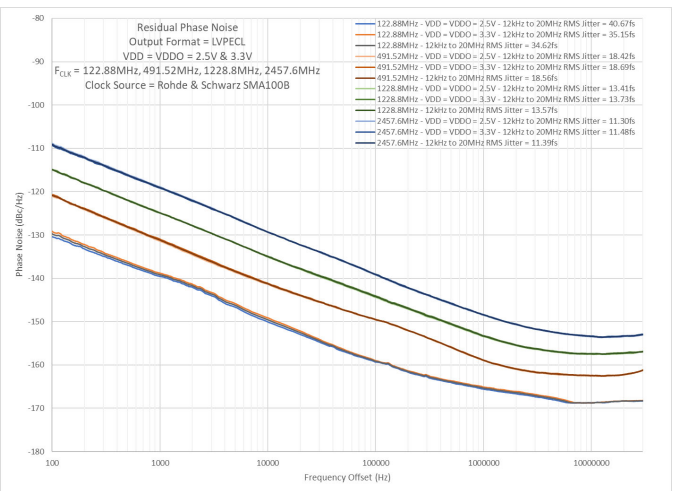


Figure 44. Residual Phase Noise Differential Input (LVPECL: 2457.6 MHz, 1228.80 MHz, 491.52 MHz, 122.88 MHz)

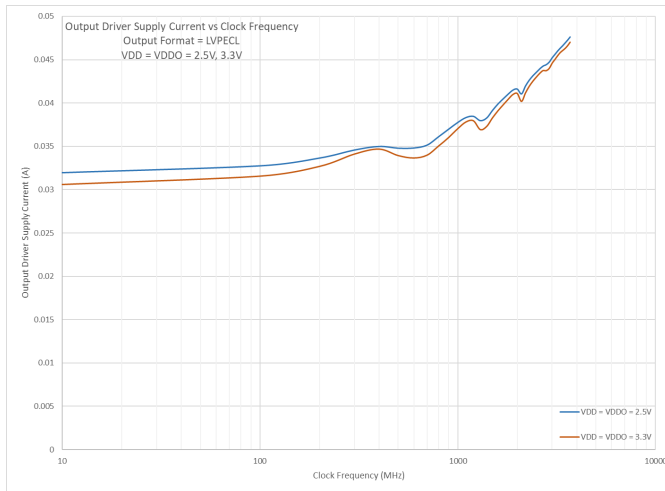


Figure 45. Supply Current Per Output vs. Frequency (LVPECL)

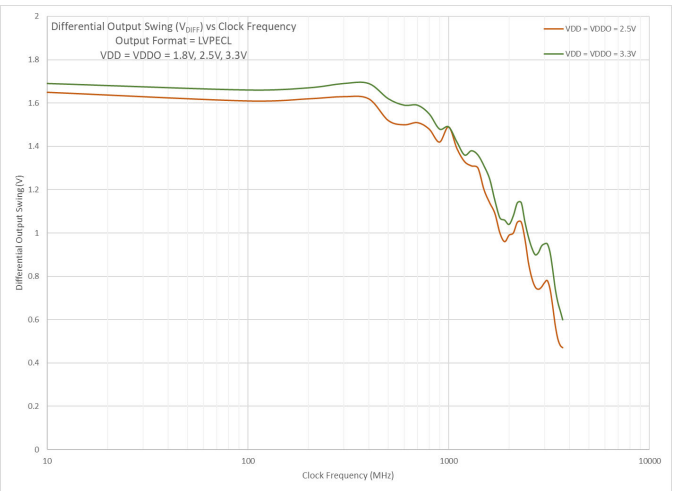


Figure 46. Differential Output Voltage Swing vs. Frequency (2.5 V, 3.3 V LVPECL)

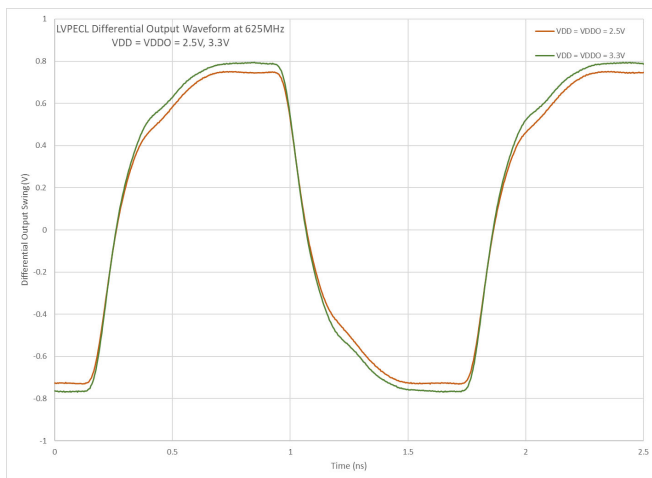


Figure 47. LVPECL Differential Output Waveform (625 MHz)

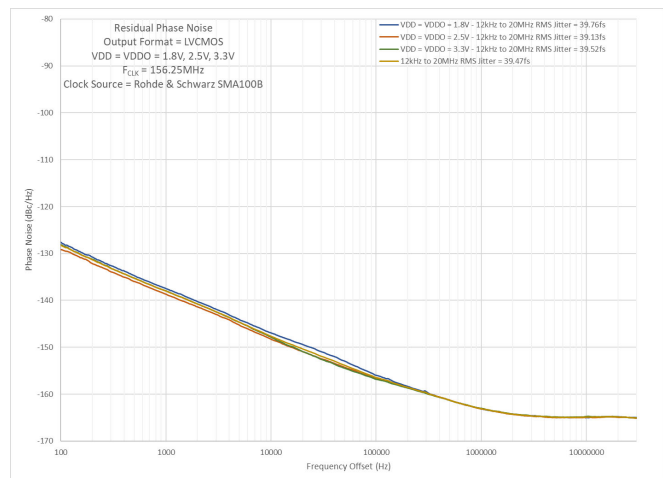


Figure 48. Residual Phase Noise Differential Input (REFOUT: 156.25 MHz)

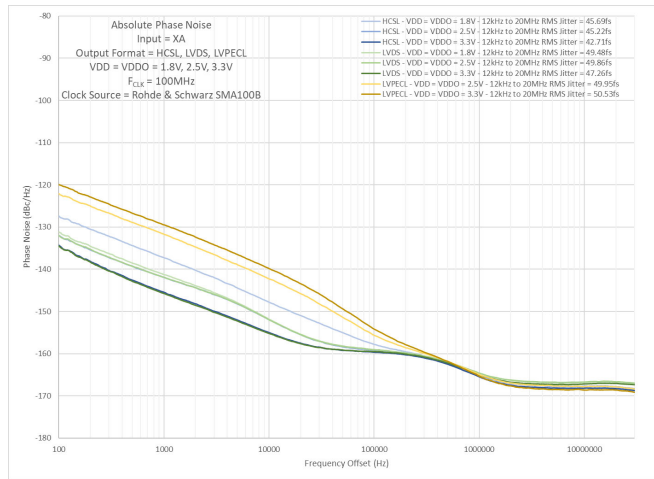


Figure 49. Absolute Phase Noise XA Clock Input (2.5 V, 3.3 V HCSL, LVDS, LVPECL: FOUT = 100 MHz)

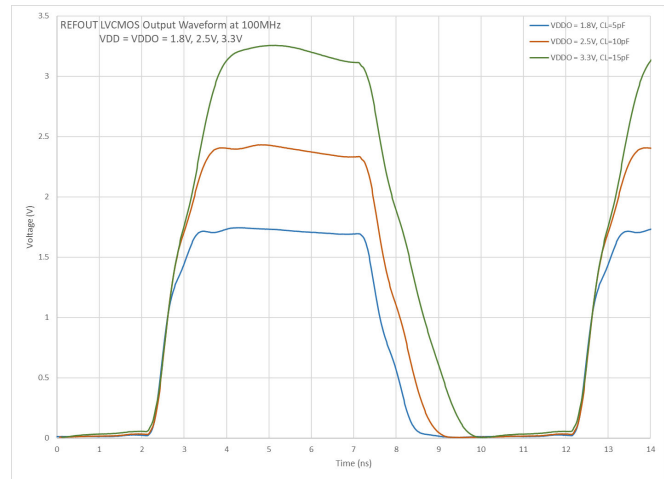


Figure 50. LVC MOS Output Waveform (100 MHz)

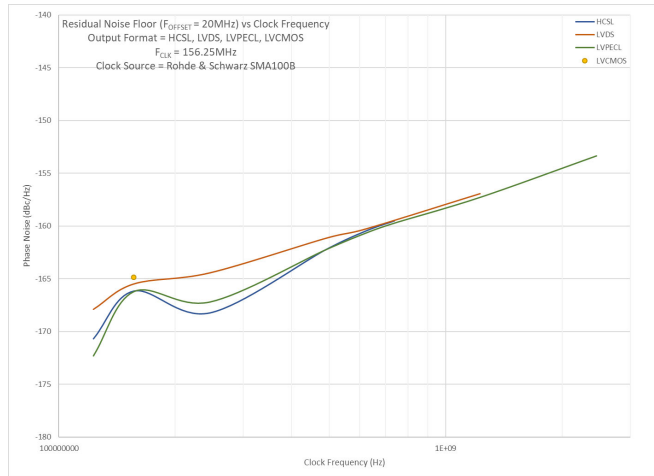


Figure 51. Residual Noise Floor (20 MHz Offset) vs. Carrier Frequency (HCSL, LVDS, LVPECL, REFOUT)

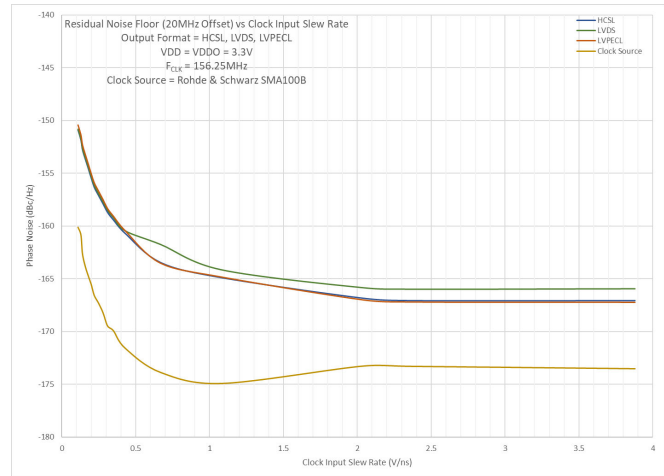


Figure 52. Residual Noise Floor (20 MHz Offset) vs. Input Slew Rate (3.3 V LVPECL, LVDS, HCSL)

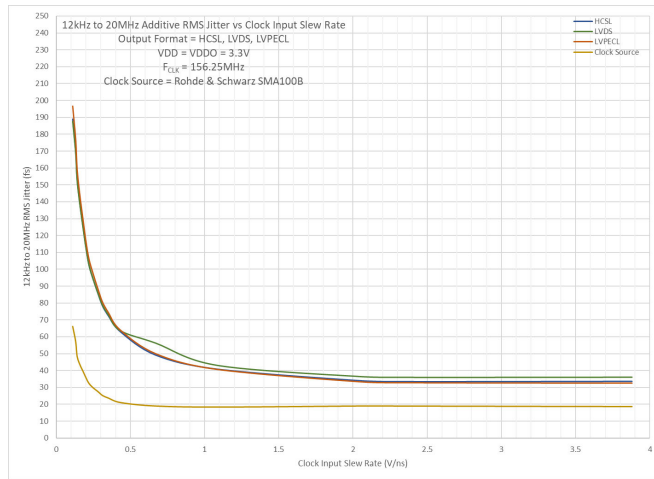


Figure 53. Additive Output Jitter vs. Input Slew Rate (3.3 V LVPECL, LVDS, HCSL)

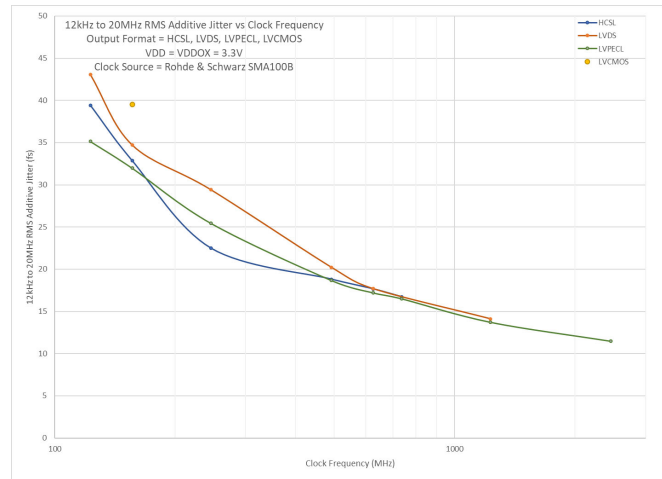


Figure 54. Additive RMS Phase Jitter vs. Output Clock Frequency (3.3 V LVCMOS, LVPECL, LVDS, HCSL)

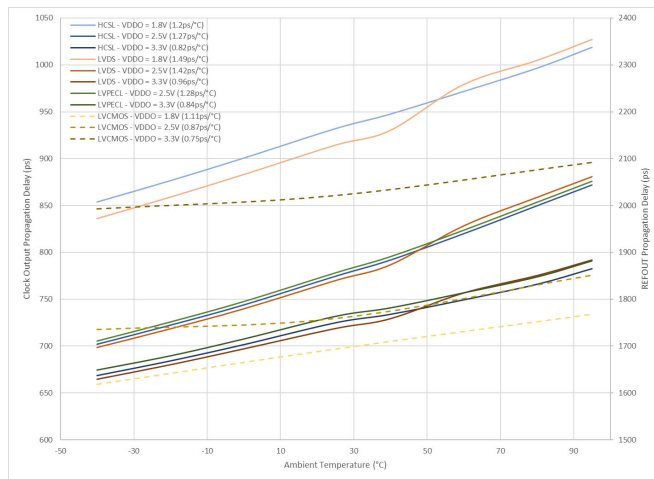


Figure 55. Propagation Delay vs. Temperature (HCSL, LVCMOS, LVDS, LVPECL)

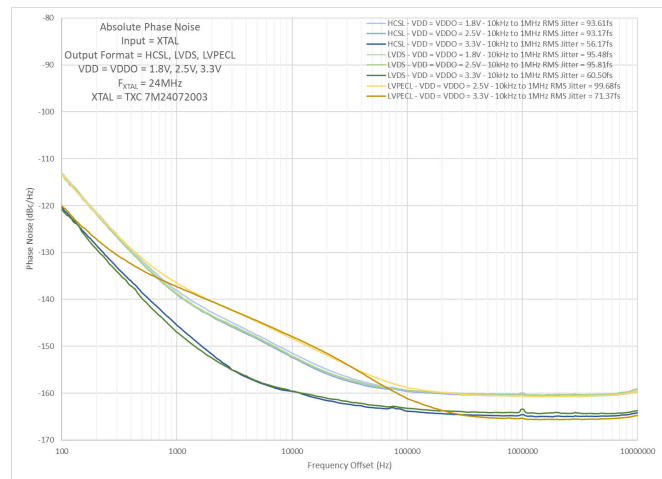


Figure 56. Absolute Crystal Phase Noise (24 MHz)

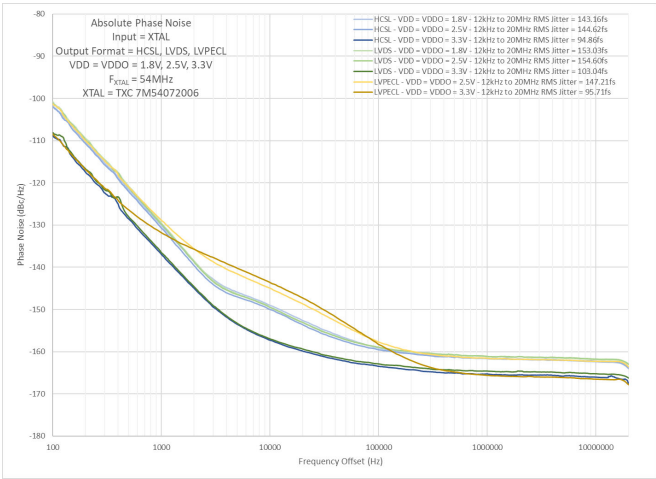


Figure 57. Absolute Crystal Phase Noise (54 MHz)

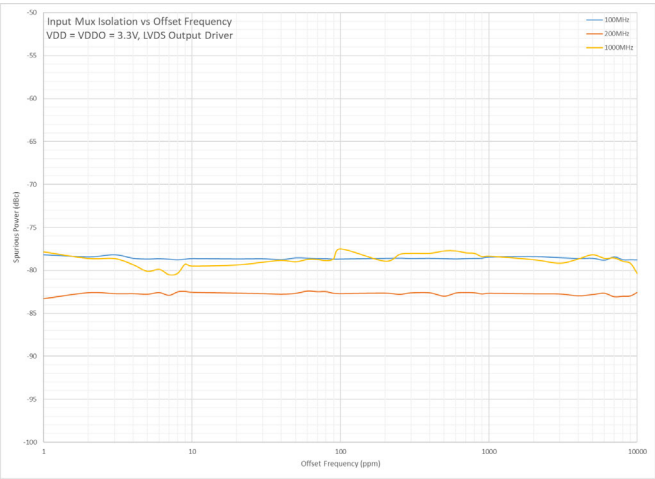


Figure 58. Input Mux Isolation vs. Offset Frequency (3.3 V LVDS)

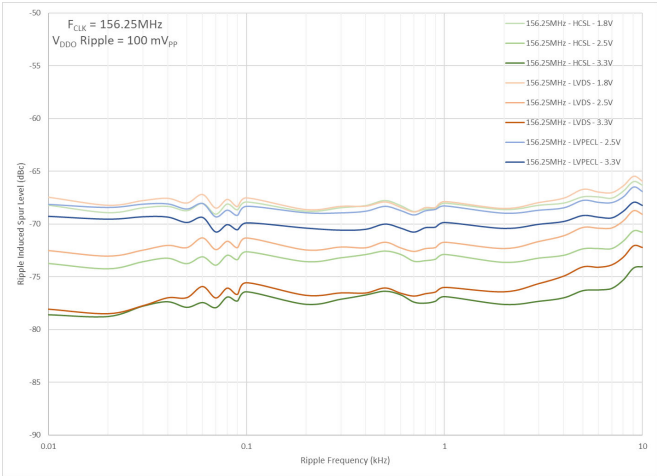


Figure 59. Power Supply Ripple Rejection vs. Offset Frequency

The phase noise and jitter plots shown above were measured using two different setups outlined below.

The setup shown in [Figure 60](#) was used for all absolute phase noise measurements, which measures total phase noise and total jitter of the combined reference clock and clock buffer. This setup:

- Uses the differential square wave of the clock synthesizer option on the Rohde and Schwarz SMA100B to provide an ultra low phase noise, square wave, differential reference clock to the clock buffer.
- Uses a balun to transform the differential output clock of the clock buffer to a single-ended output clock to be measured by the PNA.

The setup shown in [Figure 61](#) was used for all residual additive phase noise and additive RMS phase jitter measurements, which measures the actual contribution of the clock buffer to the total phase noise and total jitter by removing the contribution of external noise sources (ex: power supplies and reference clock). This setup:

- Uses the differential square wave of the clock synthesizer options on the Rohde and Schwarz SMA100B to provide an ultra-low phase noise, square wave reference clock to the clock buffer and the FSWP.
- Uses the additive phase noise measurement option on the Rohde and Schwarz FSWP to extract the residual additive phase noise of the clock buffer and calculate the resulting additive RMS phase jitter.
- Uses baluns to transform between differential and single-ended clock signals to match the expected inputs of the clock buffer, FSWP, and LNAs.

In order to perform the residual additive phase noise measurements, three matching copies of the reference clock are required with one copy going to the clock buffer and the other two going to the LO Aux inputs on the FSWP. To achieve this, the reference clock must go through a power divider and then an LNA plus attenuation stage, using matching ultra-low noise LNAs, to provide matching copies of the reference clock with amplitudes scaled to match the requirements of the clock buffer input receiver and the FSWP LO Aux inputs.

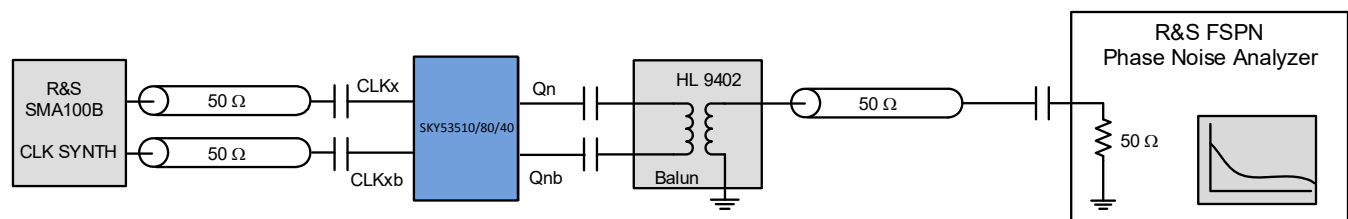


Figure 60. Measurement Setup for Absolute Phase Noise Measurements

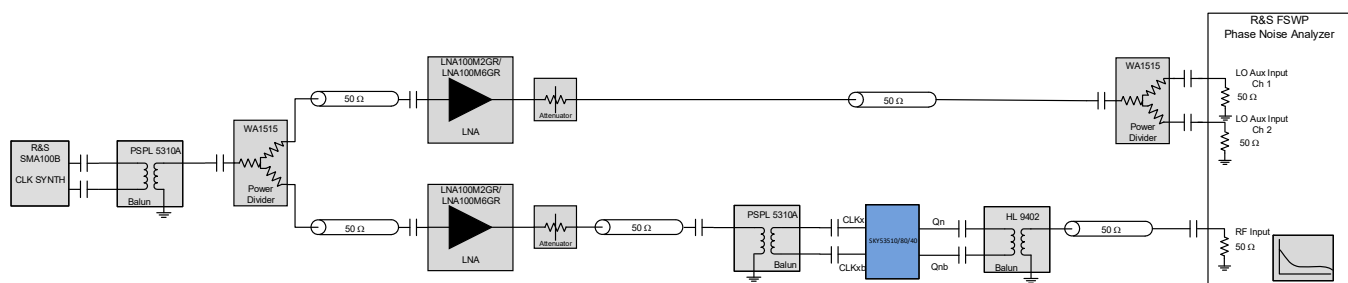


Figure 61. Measurement Setup for Residual Additive Phase Noise Measurements

7. Package and Handling Information

7.1. 48-QFN Package Diagram

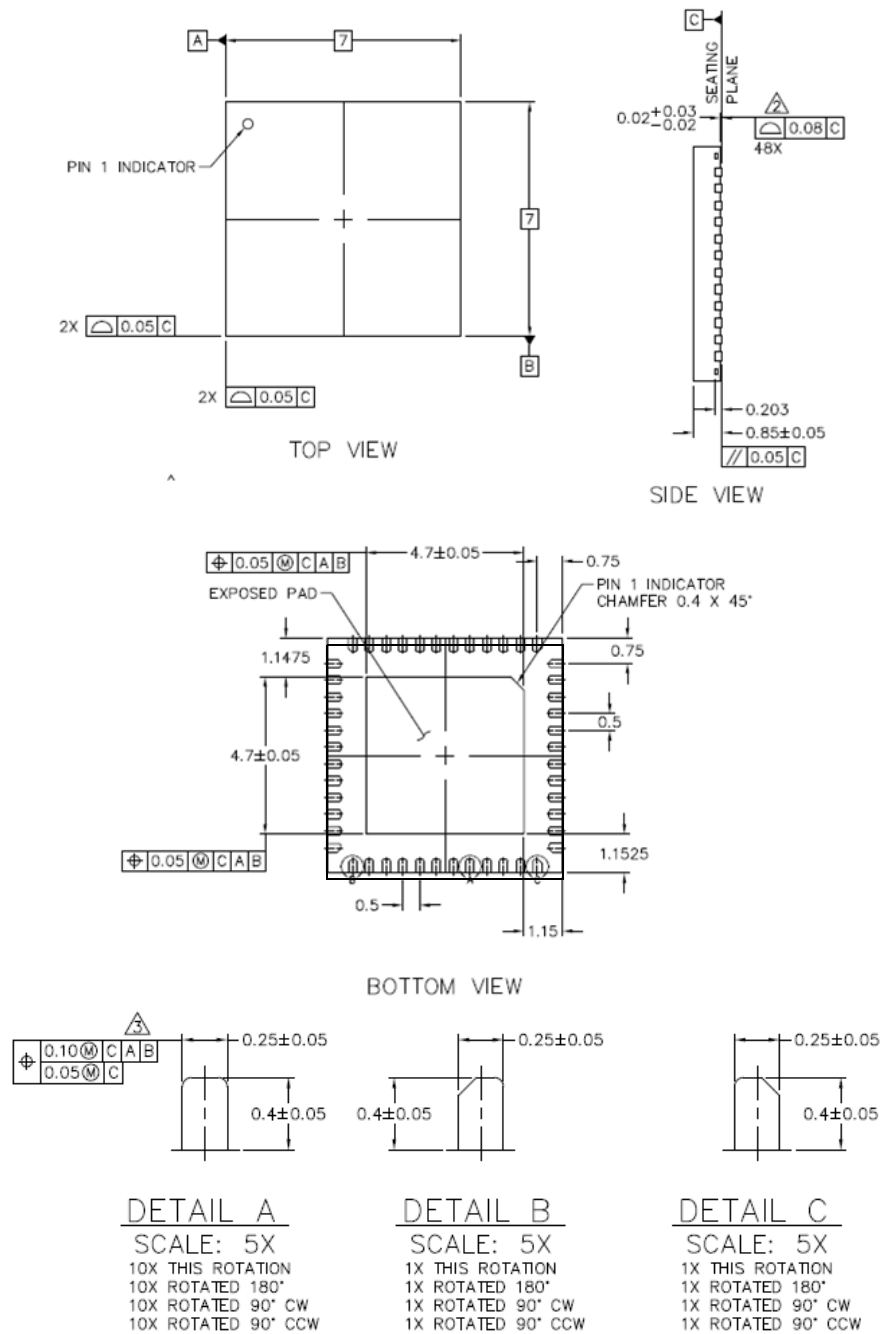


Figure 62. 7x7 mm 48-QFN Package Dimensions

7.2. 40-QFN Package Diagram

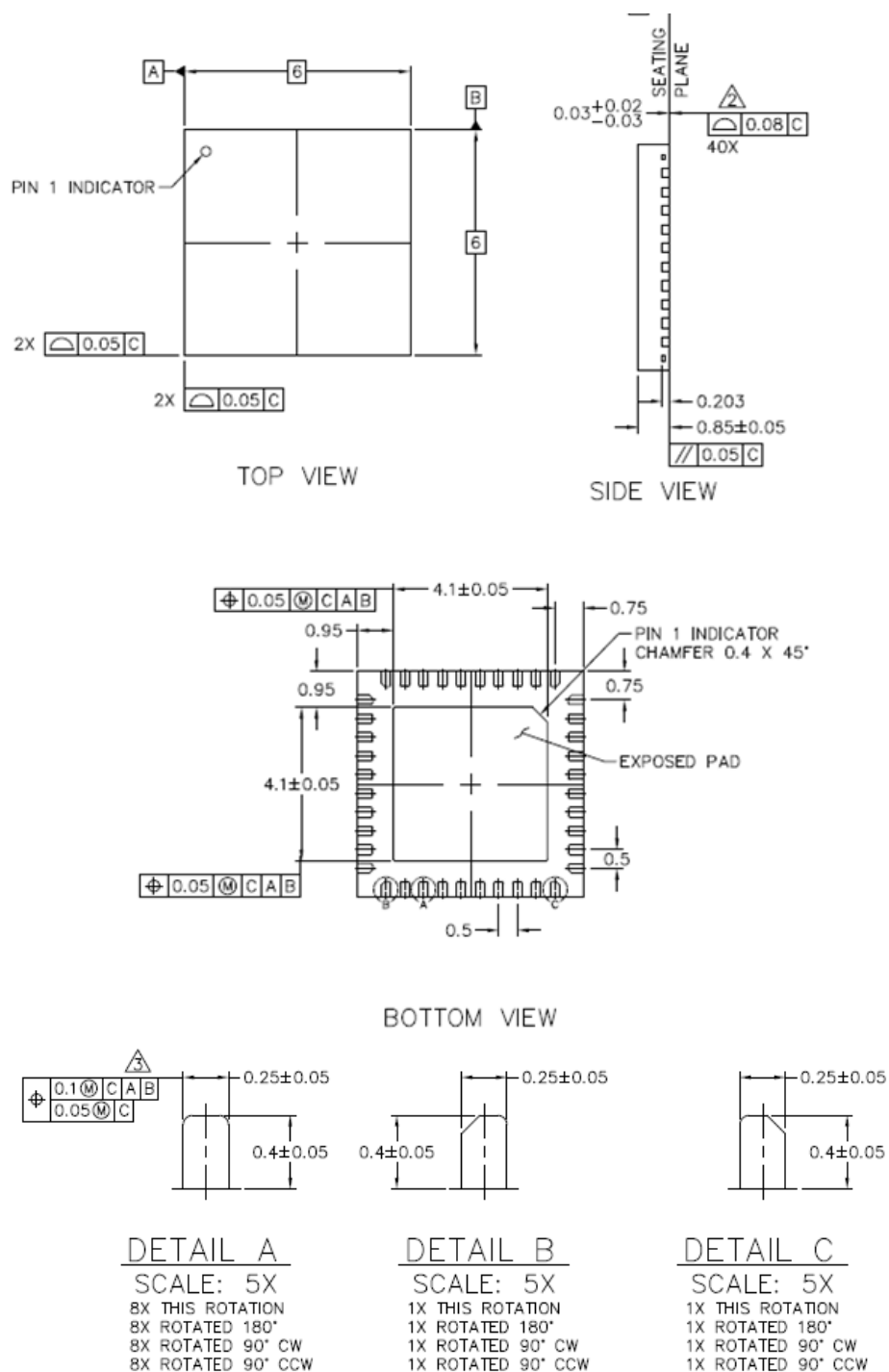


Figure 63. 6x6 mm 40-QFN Package Dimensions

7.3. 32-QFN Package Diagram

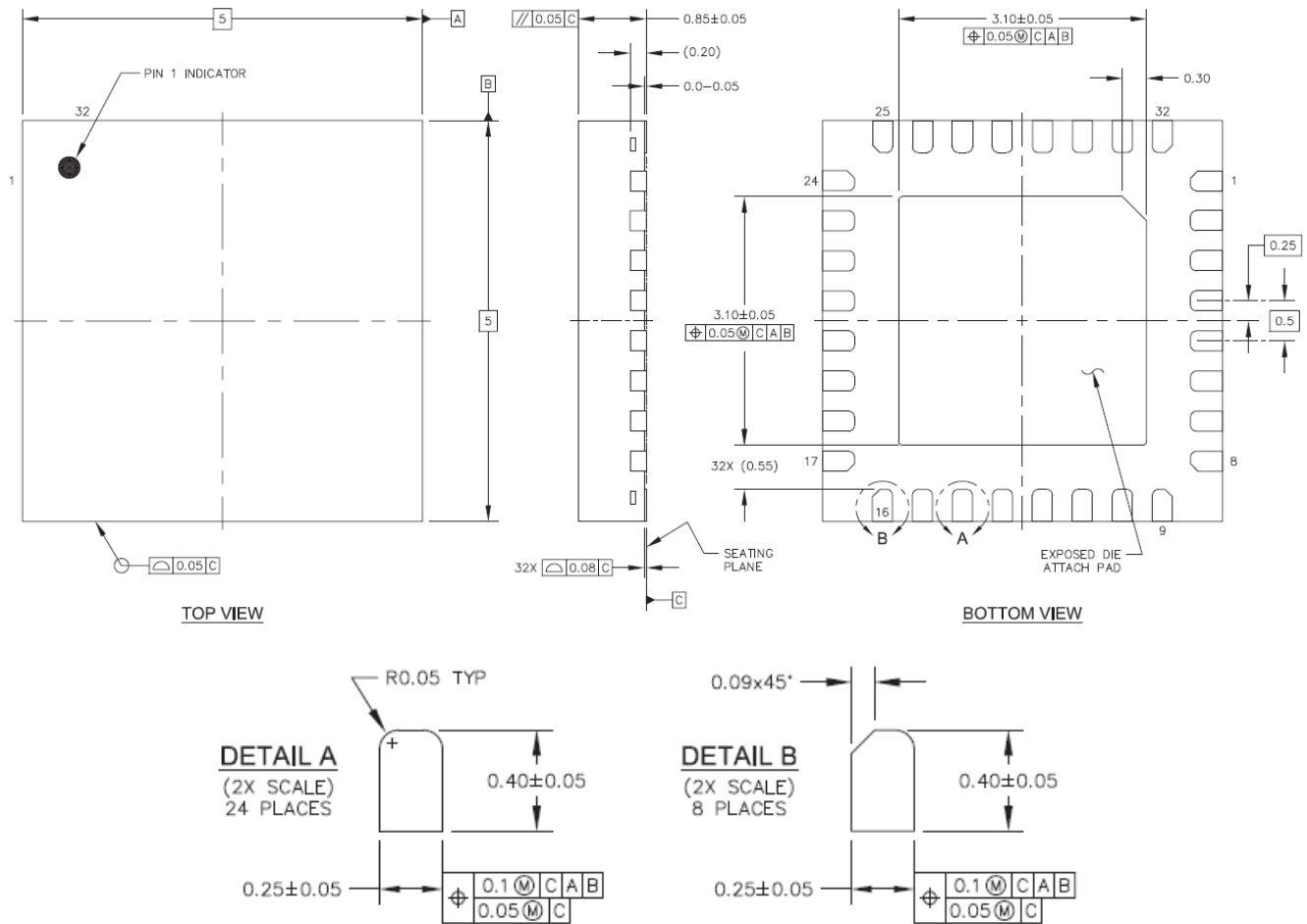


Figure 64. 5x5 mm 32-QFN Package Dimensions

8. Land Patterns

8.1. 48-QFN Land Pattern

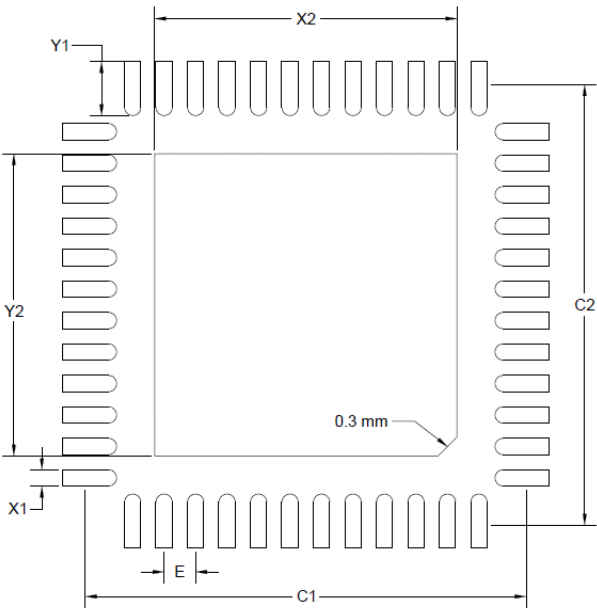


Figure 65. 7x7 mm 48-QFN Land Pattern

Table 22. 7x7 mm 48-QFN Land Pattern Dimensions

Dimension	mm	Notes
C1	7.00	General 1. All dimensions shown are in millimeters (mm) unless otherwise noted. 2. This land pattern design is based on the IPC-7351 guidelines. Solder Mask Design 1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad. Stencil Design 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release. 2. The stencil thickness should be 0.125 mm (5 mils). 3. The ratio of stencil aperture to land pad size should be 1:1 for all perimeter pads. 4. A 2x2 array of 1.35 mm square openings on 1.55 mm pitch should be used for the center ground pad. Card Assembly 1. A No-Clean, Type-3 solder paste is recommended. 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for small body components.
C2	7.00	
E	0.50	
X1	0.26	
Y1	0.80	
X2	4.80	
Y2	4.80	

8.2. 40-QFN Land Pattern

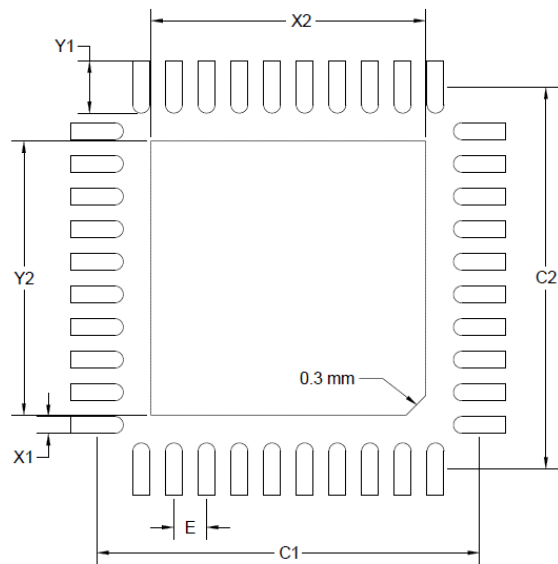


Figure 66. 6x6 mm 40-QFN Land Pattern

Table 23. 6x6 mm 40-QFN Land Pattern Dimensions

Dimension	mm	Notes
C1	6.00	General 1. All dimensions shown are in millimeters (mm) unless otherwise noted. 2. This Land Pattern Design is based on the IPC-7351 guidelines. Solder Mask Design 1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad. Stencil Design 1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release. 2. The stencil thickness should be 0.125 mm (5 mils). 3. The ratio of stencil aperture to land pad size should be 1:1 for all perimeter pads. 4. A 2x2 array of 1.35 mm square openings on 1.55 mm pitch should be used for the center ground pad. Card Assembly 1. A No-Clean, Type-3 solder paste is recommended. 2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.
C2	6.00	
E	0.50	
X1	0.26	
Y1	0.80	
X2	4.20	
Y2	4.20	

8.3. 32-QFN Land Pattern

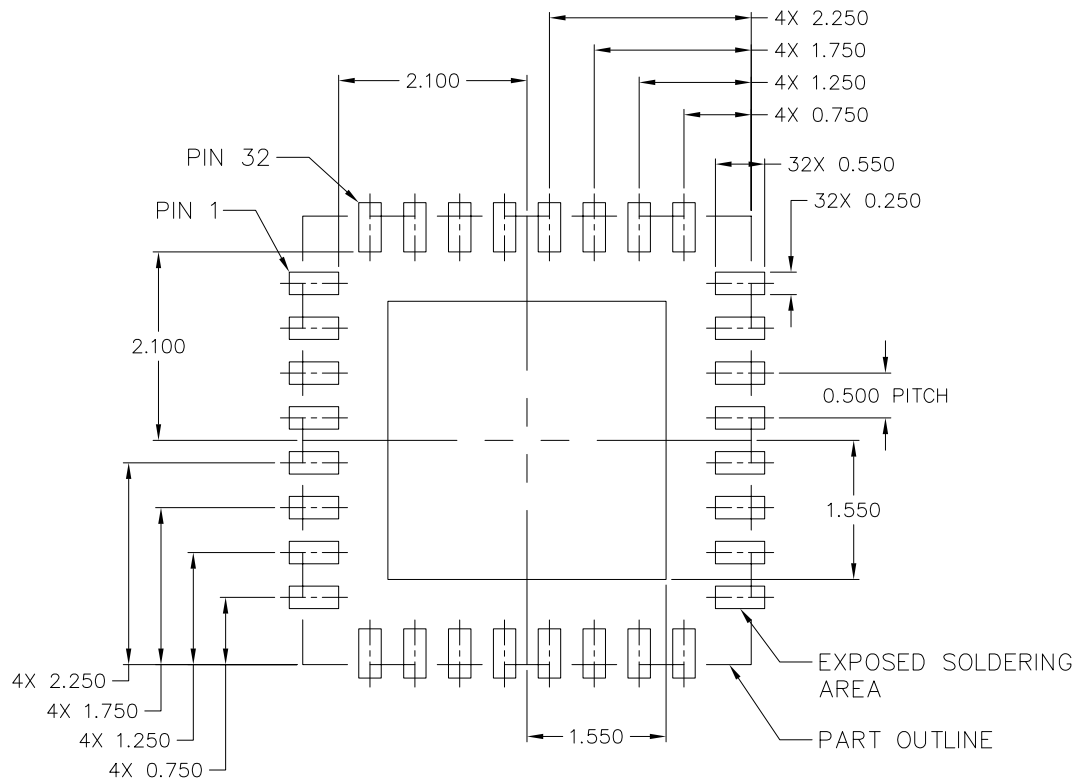


Figure 67. 5x5 mm 32-QFN Land Pattern

9. Top Markings

9.1. SKY53510/80/40 Top Markings

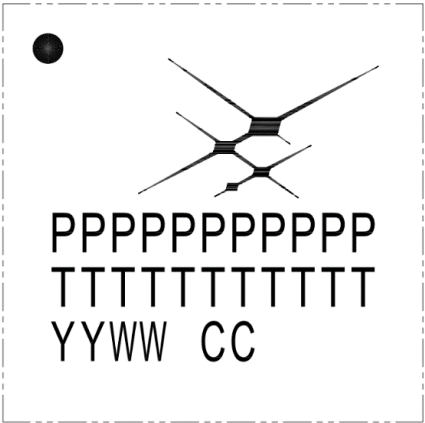


Figure 68. SKY53510/80/40 Top Marking

Table 24. SKY53510/80/40 Top Marking Explanation

Mark Method	Laser	
Pin 1 Mark	Circle – 0.50 mm diameter	Top-left justified
Sky Logo	Logo Height: ~2.33	Rightmost edge of Sky logo, left-justified with last character of Line 1 text.
Font Size	2.0 Point (26 mils)	Left-justified
Line 1 Format	PPPPPPPPPP = Device part number	53510-A for SKY53510-A-GM 53580-A for SKY53580-A-GM 53540-A for SKY53540-A-GM
Line 2 Format	TTTTTTTTTT = Mfg code	Manufacturing code assembly lot number.
Line 3 Format	YY = Calendar year WW = Work week CC = Country code	Assigned by assembly supplier. Corresponds to the year and work week of the mold date.

10. Ordering Guide

Table 25. Product Family Overview

Number	Description	Input MUX	Inputs	Outputs	Tristate Option	Synchronous OE
SKY53510-A -GM	10 output universal buffer with 3:1 input mux and XO	Yes	2 plus crystal	10 Diff + 1 SE	Each Bank of 5	SE output
SKY53580-A-GM	8 output universal buffer with 3:1 input mux and XO	Yes	2 plus crystal	8 Diff + 1 SE	Each Bank of 4	SE output
SKY53540-A-GM	4 output universal buffer with 3:1 input mux and XO	Yes	2 plus crystal	4 Diff + 1 SE	Both Bank of 2	SE output

Table 26. SKY535xx Ordering Guide

Part Number	Package	Pb-Free, ROHS-6	Ambient Temperature Range
SKY53510-A-GM ¹	7x7 mm 48-QFN	Yes	–40 to 95 °C
SKY53580-A-GM ¹	6x6 mm 40-QFN	Yes	–40 to 95 °C
SKY53540-A-GM ¹	5x5 mm 32-QFN	Yes	–40 to 95 °C
SKY53510-EVB	Evaluation Board	—	—

1. Add an "R" at the end of the part number to denote tape and reel ordering option.

11. Revision History

Revision	Date	Description
A	August, 2025	Initial release.

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